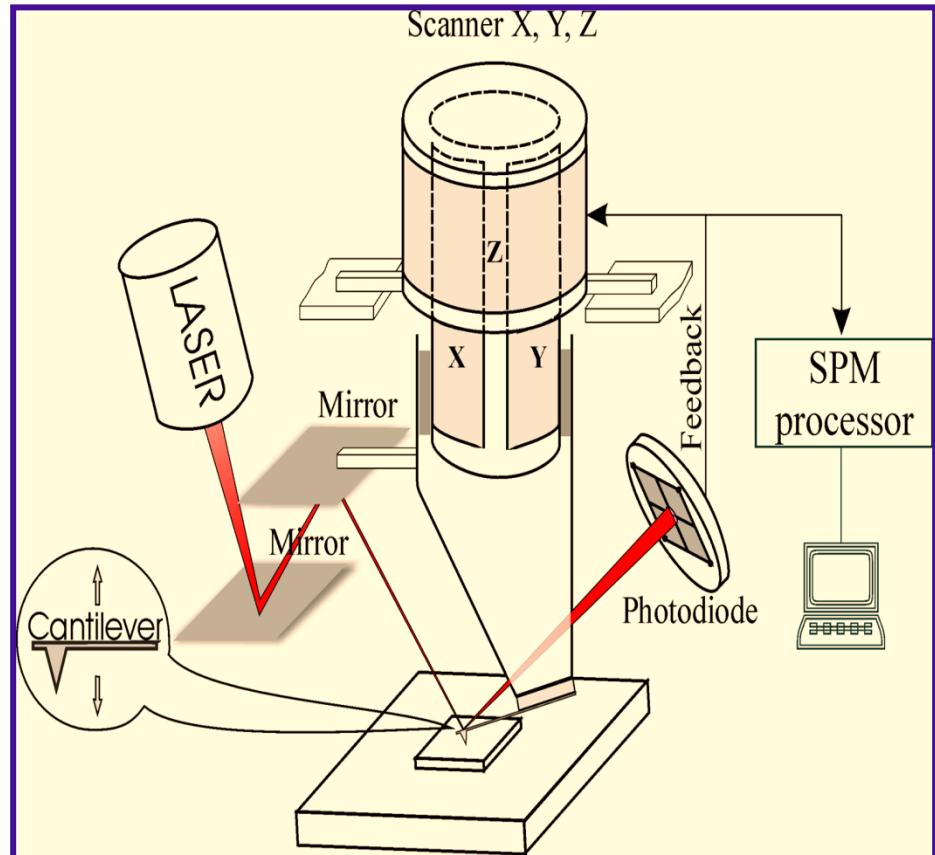
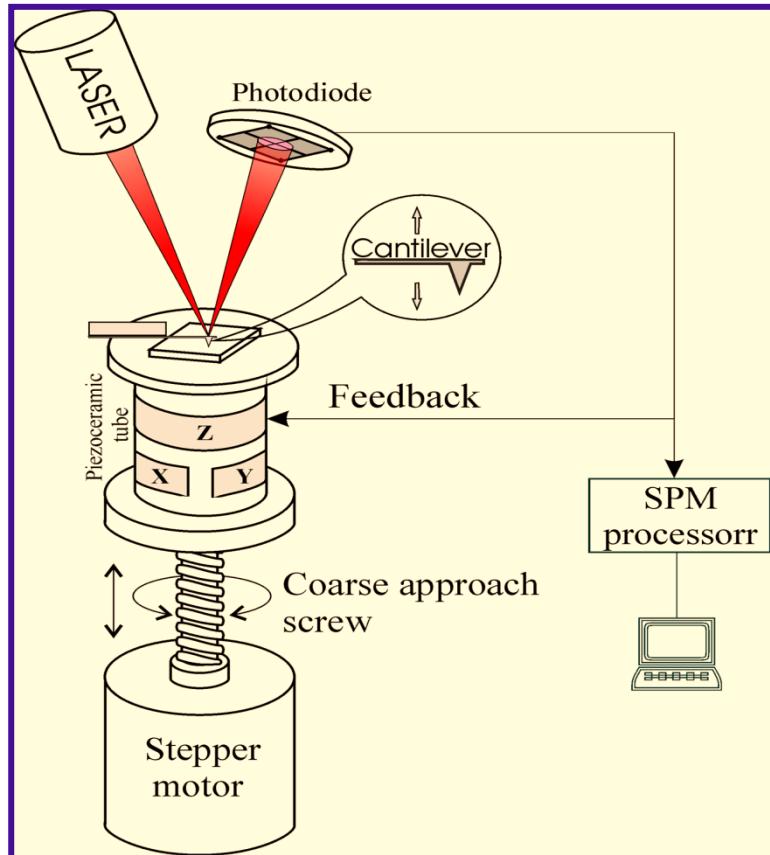


АТОМНО-СИЛОВОЙ МИКРОСКОП



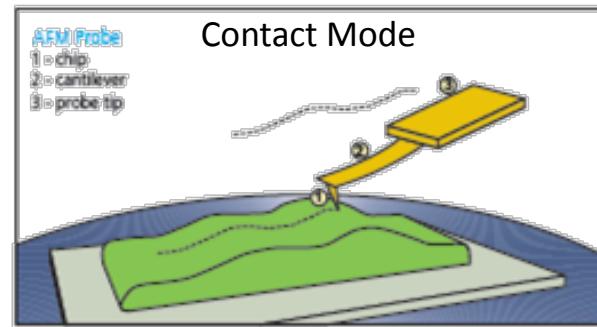
Сканирование образцом

Сканирование зондом

АСМ для исследования рельефа

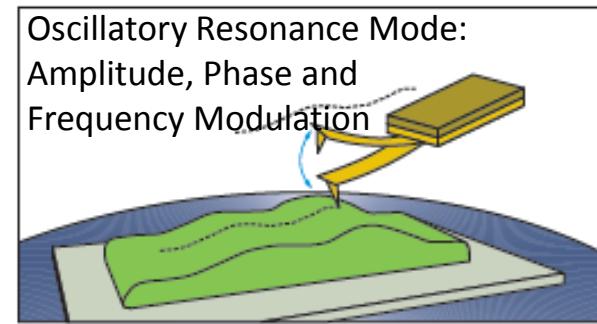
Контактная методика

*Lateral force imaging, force modulation,
contact resonance, PFM*



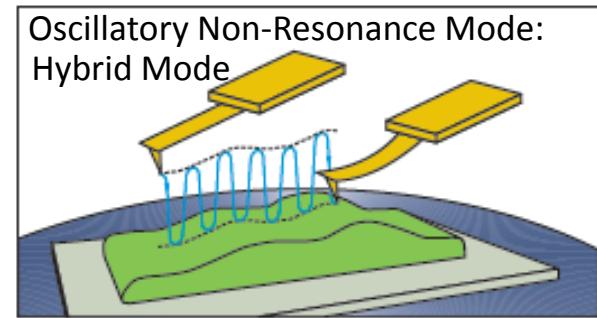
Осцилляционные резонансные методики

Amplitude modulation with phase and frequency imaging, frequency modulation, single- and double pass methods



Осцилляционные ненезонансные методики

Jumping mode, HybriD™ mode, etc



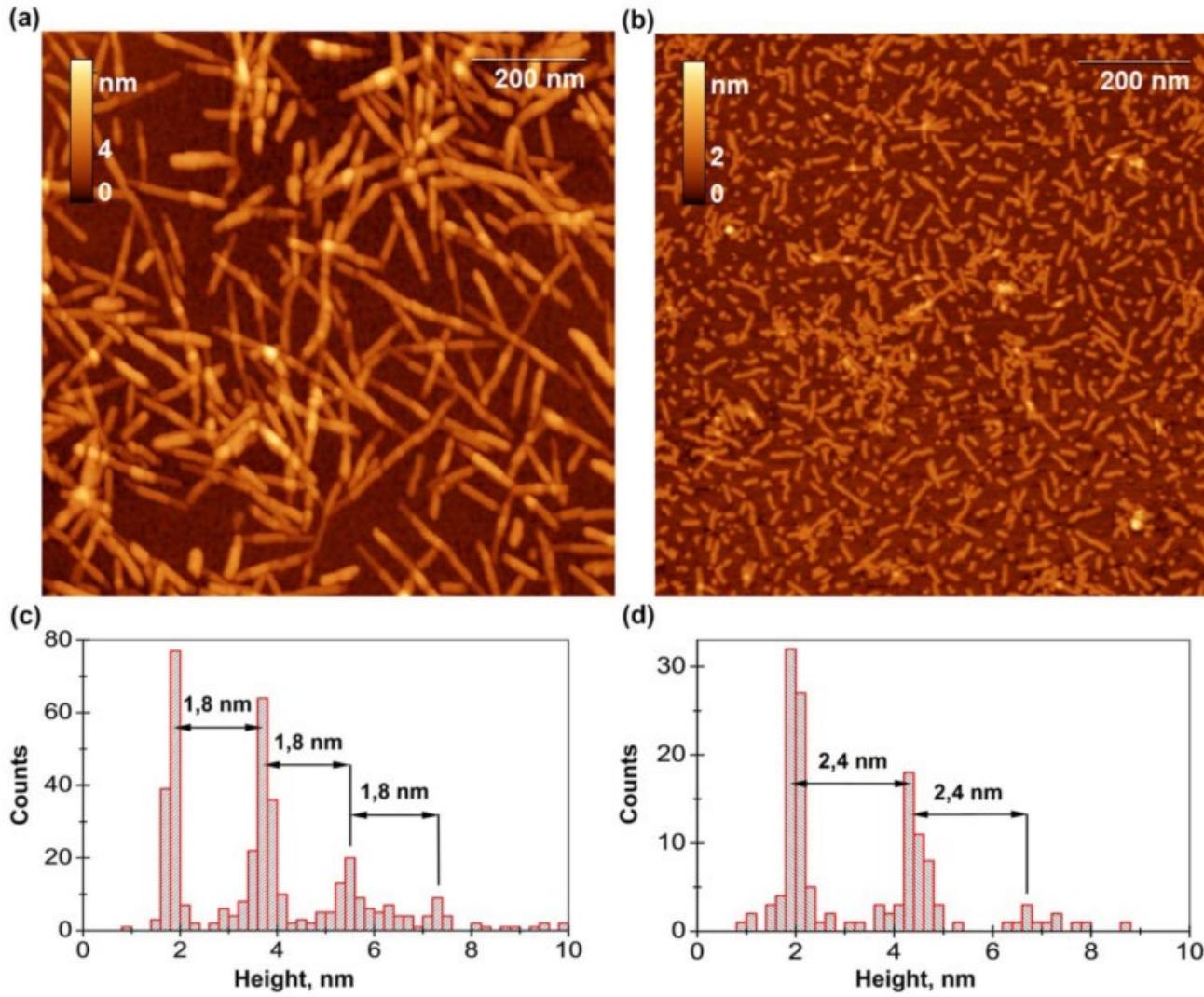
AM-ACM (полуконтакт)

Possible names:

- Tapping Mode
- Amplitude Modulation AFM
- Semicontact Mode
- Intermittent Contact Mode
- AC-Mode
- Non-Contact Mode
- etc...



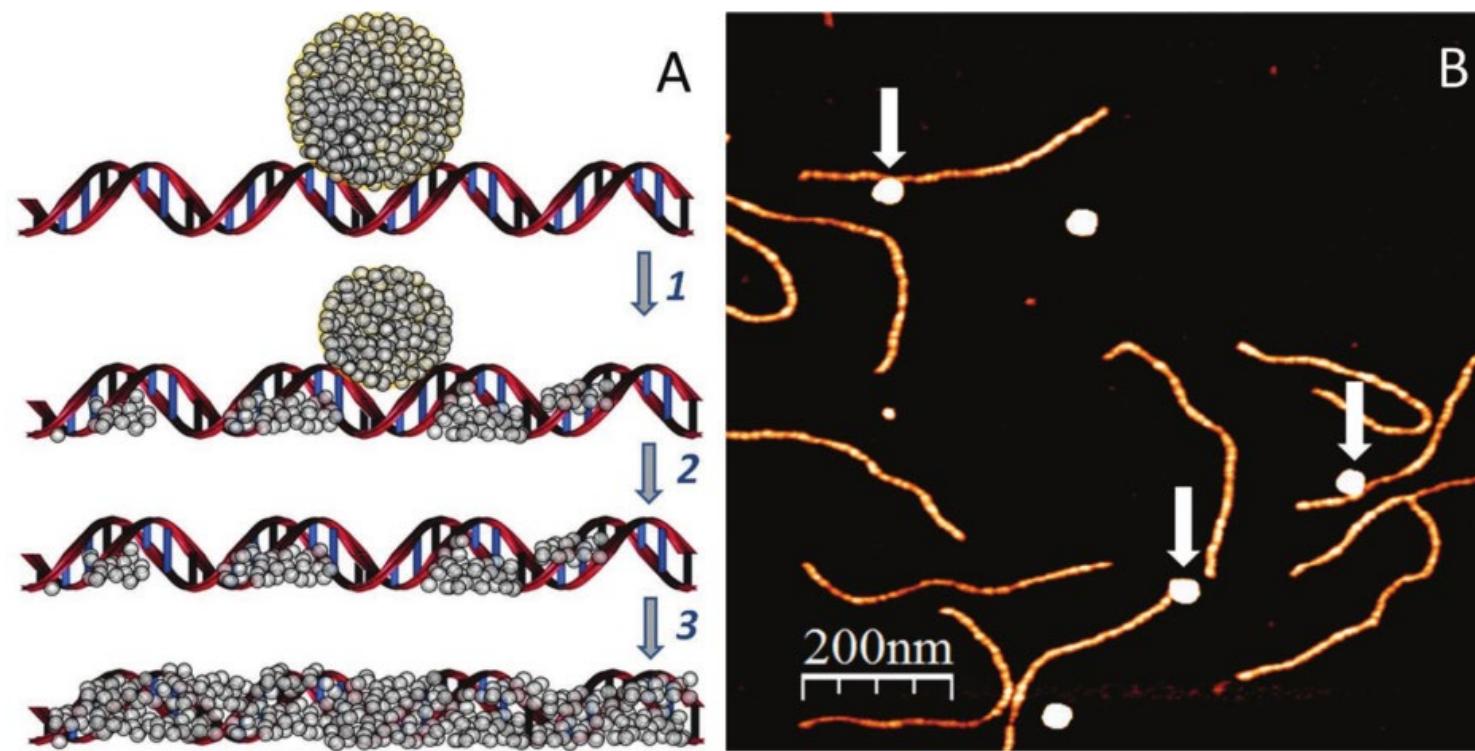
Исследования морфологии фибрил RADA-16-I and RLDL-16-I



AFM images of RADA-16-I and RLDL-16-I fibrils. (a) AFM image of RADA-16-I fibrils deposited on mica, (b) AFM image of RLDL-16-I fibrils deposited on mica (c) Histogram of RADA-16-I fibrils height distribution showing 1.8 nm gap between the peaks, (d) histogram of RLDL-16-I fibrils height distribution showing 2.4 gap between the peaks

D. Bagrov, Y. Gazizova, V. Podgorsky, I. Udovichenko, A. Danilkovich, K. Prusakov and D. Klinov, "Morphology and aggregation of RADA-16-I peptide Studied by AFM, NMR and molecular dynamics simulations", *Biopolymers*, vol. 106, no. 1, pp. 72-81, 2016.

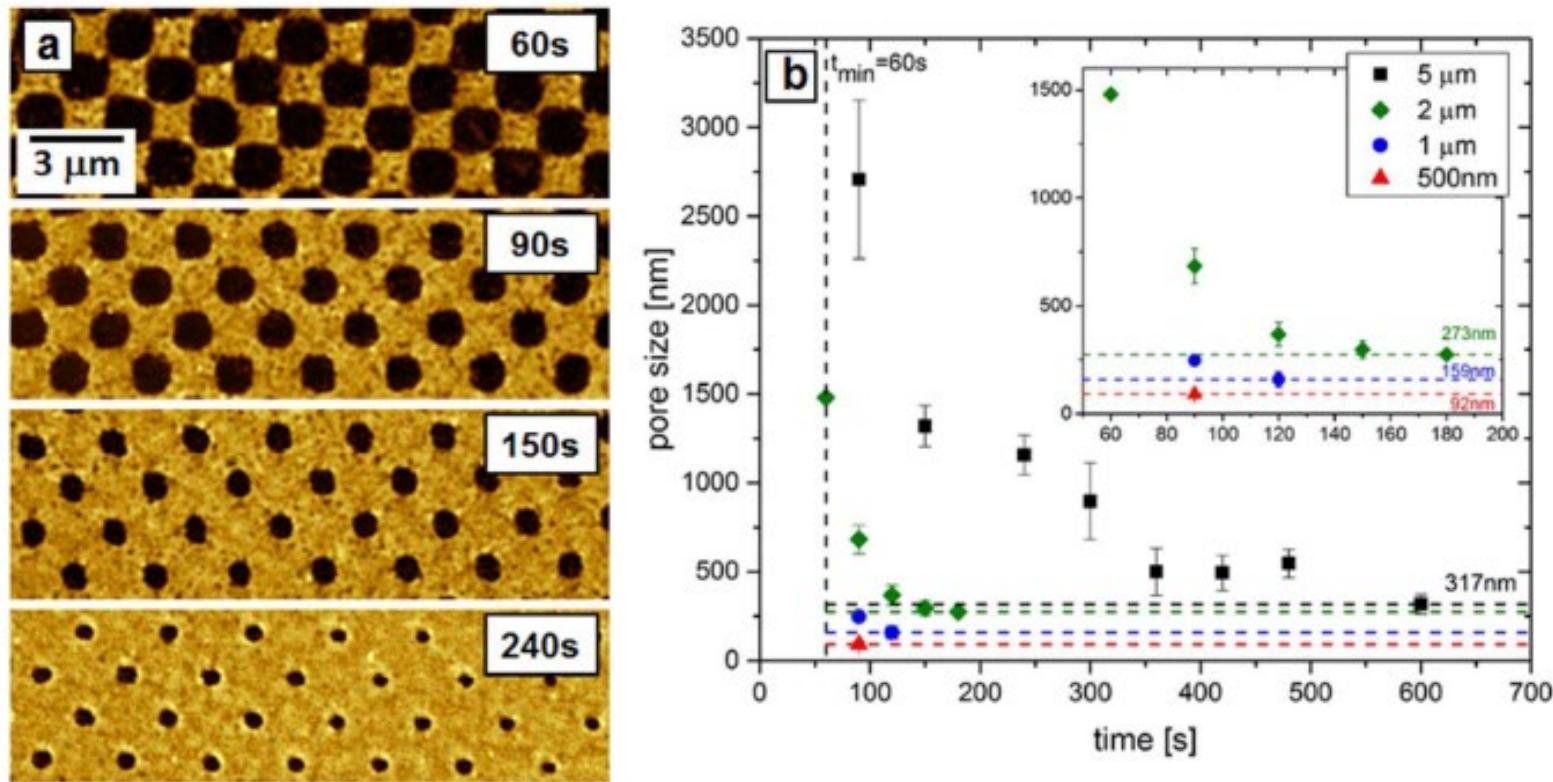
Исследования молекул ДНК, заполненных серебром (E-DNA)



Tentative scheme of A) E-DNA formation and B) AFM imaging of an intermediate stage of E-DNA formation. A) (1) The AgNP binds to DNA and donates its atoms to the nucleic acid. As a result, silver atoms and few atoms clusters are positioned within or on the DNA molecules. (2) The NP dissociates, leaving some of its atoms bound to the DNA. (3) A number of binding–dissociation cycles yield E-DNA. B) The DNA was incubated with AgNPs for 20 h and imaged by AFM. AgNPs bound to the DNA molecules are indicated by the arrows.

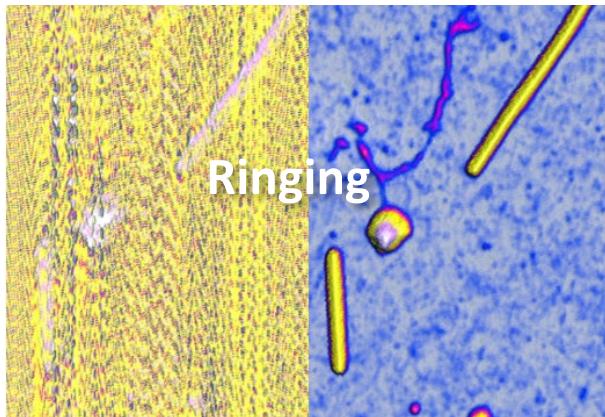
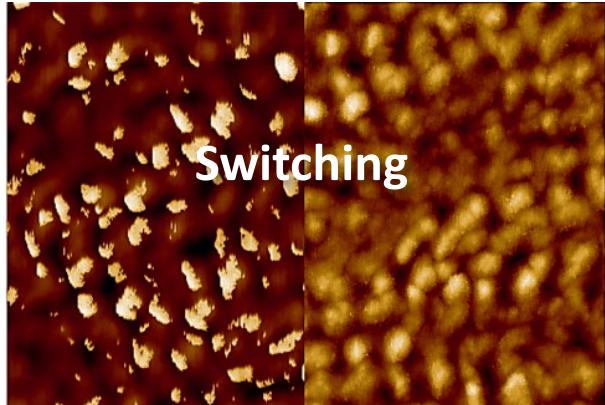
Eidelstein, G., Fardian-Melamed, N., Gutkin, V., Basmanov, D., Klinov, D., Rotem, D., Levi-Kalisman, Y., Porath, D. & Kotlyar, A. DNA-Metalization: Synthesis and Properties of Novel Silver-Containing DNA Molecules (Adv. Mater. 24/2016). *Advanced Materials* 28, 4944-4944 (2016).

Исследования перфорированных пленок гидрогеля

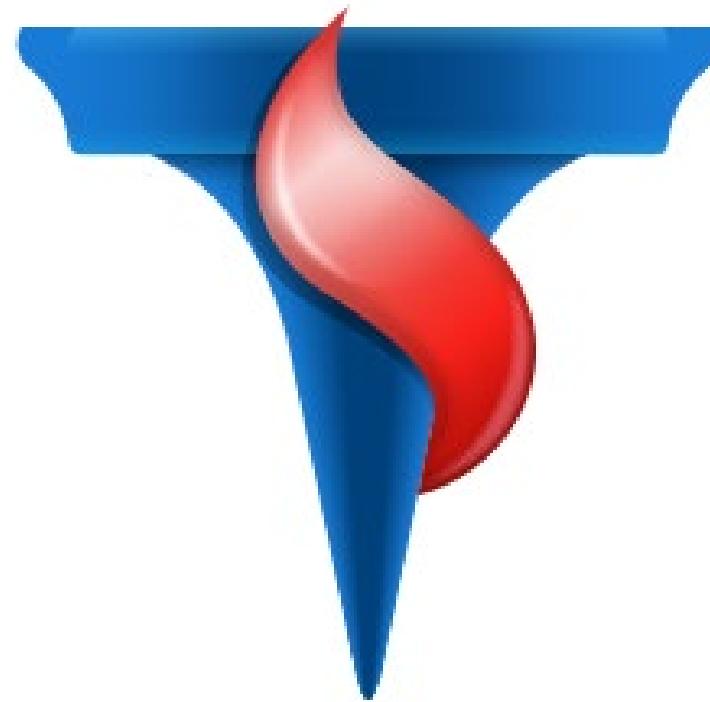


(a) AFM micrographs of the structured poly(NIPAm-co-10%MABP) + DR1 hydrogel film with a 2 μm period for different irradiation times. The pore diameter decreases and the pore spacing increases with increasing irradiation time. The depth of the pores is about 280 nm. (b) The dependence of the pore size on irradiation time at different periodicities of the interference pattern.

Jelken, J., Pandiyarajan, C., Genzer, J., Lomadze, N. & Santer, S. Fabrication of Flexible Hydrogel Sheets Featuring Periodically Spaced Circular Holes with Continuously Adjustable Size in Real Time. *ACS Applied Materials & Interfaces* 10, 30844-30851 (2018).

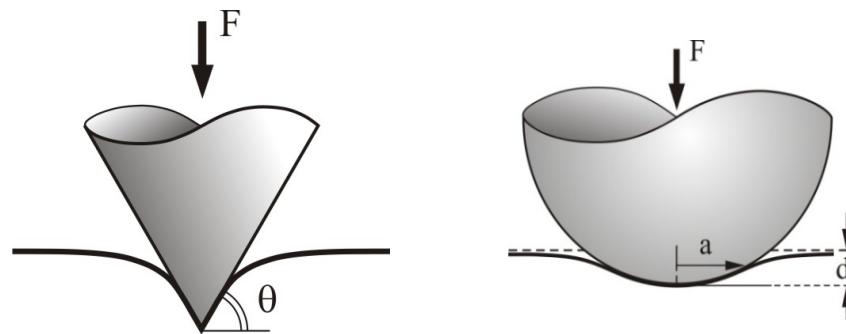
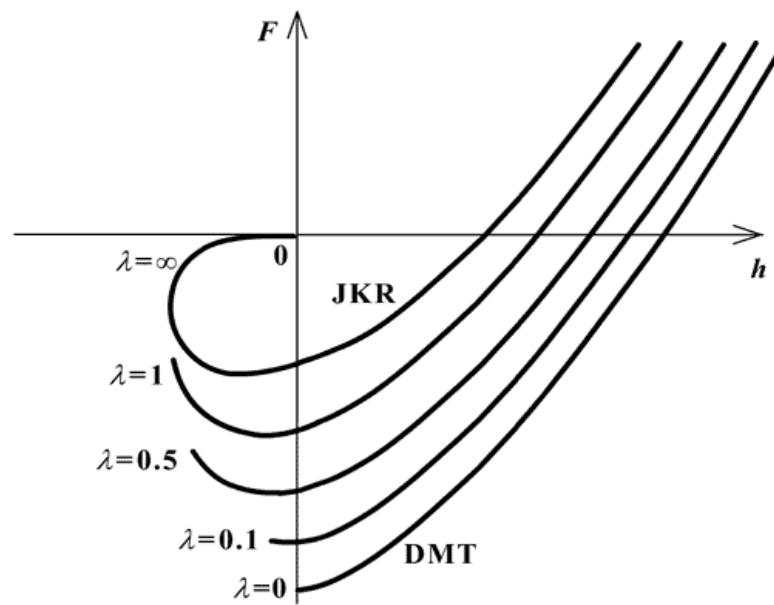


ScanTronic™



Straightforward for beginners
Helpful for experts

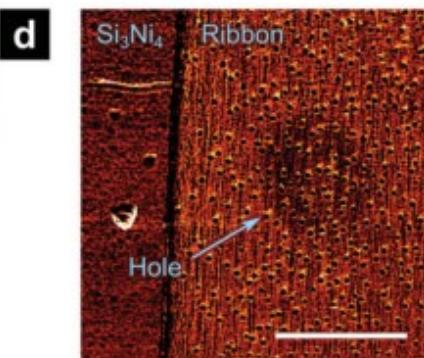
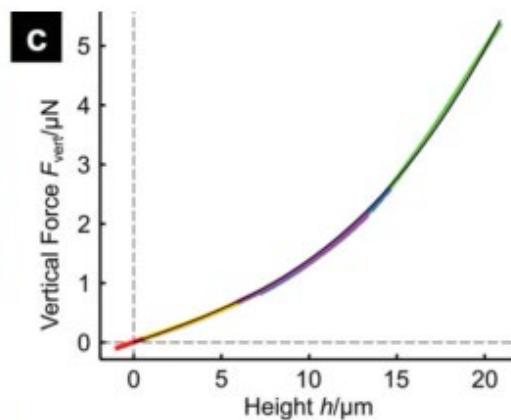
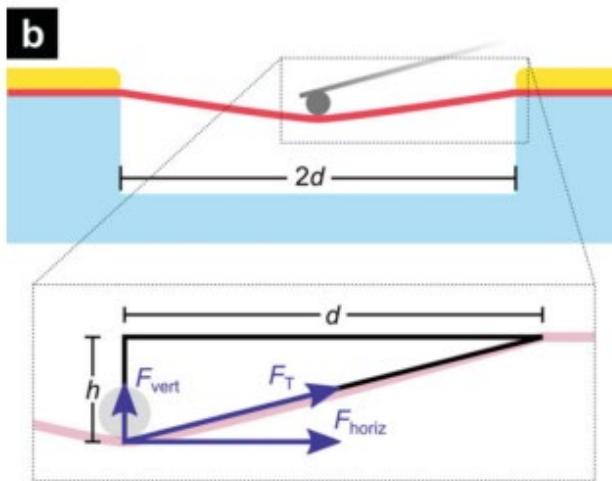
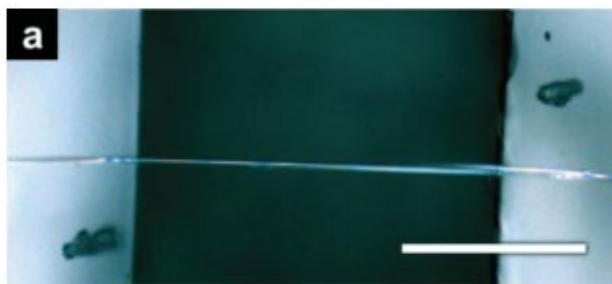
Количественные измерения механических свойств с использованием силовых кривых (QNM)



Коричневый отшельник



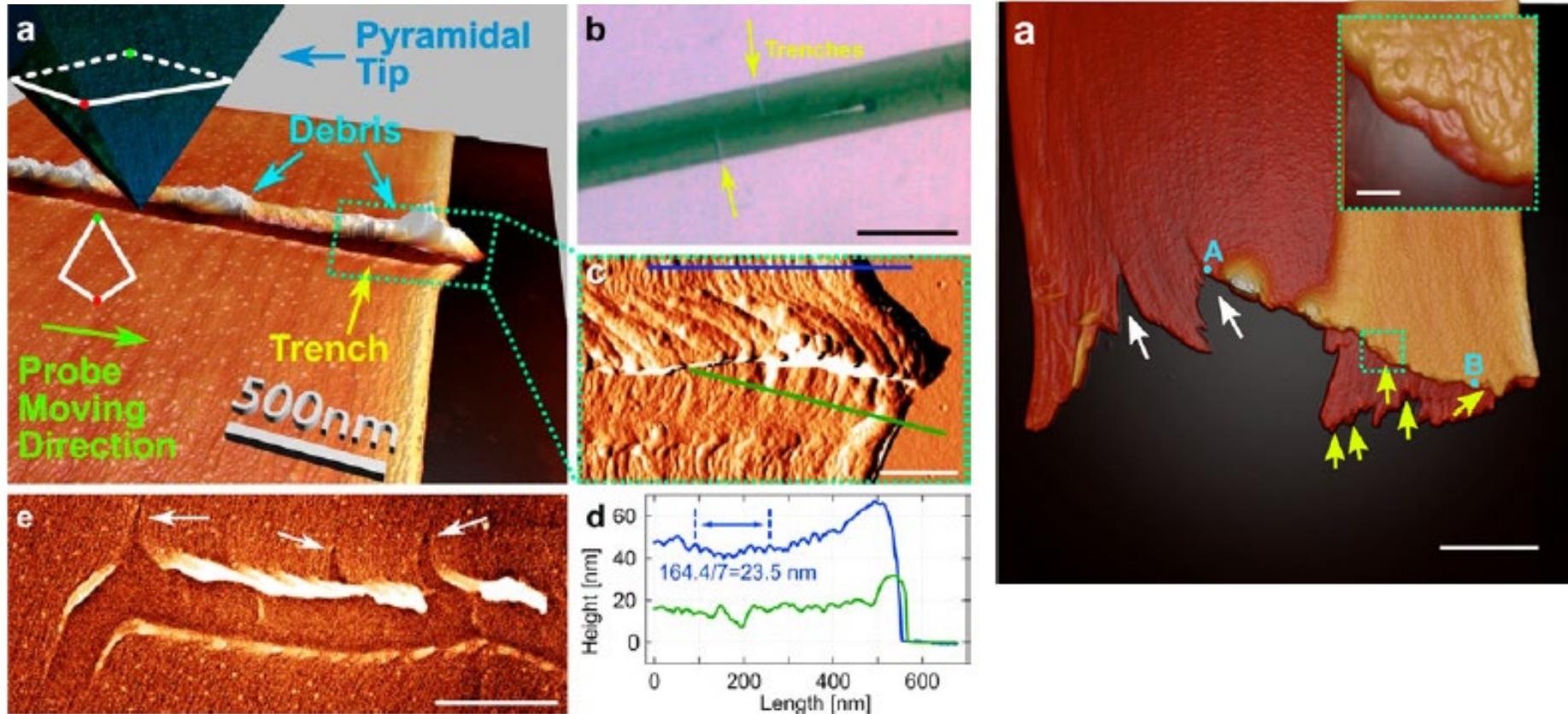
Наномеханические измерения паутины коричневого отшельника



a) Top view of the mechanical testing setup (optical micrograph). Scale bar: 200 μm . b) Schematic of the setup: a Loxosceles fiber (rose) was suspended over a gap in a glass substrate (light blue) and secured with cyanoacrylate glue (amber). A blunted AFM probe (grey) strained the silk via vertical deflection, while simultaneously measuring the vertical component F_{vert} of the fiber tensile force F_T as a function of the probe indentation height h .

c) Obtained force curves (various colors) and the fitted model (black). d) AFM tapping-mode phase image of a silk ribbon suspended over a 1 μm -diameter hole in a silicon nitride substrate. The ribbon covers the hole and can sustain forces exerted by the AFM probe. Phase imaging reveals the position of the hole since the ribbon deflects in the suspended area (scale bar: 1 μm).

Наномеханические измерения паутины коричневого отшельника

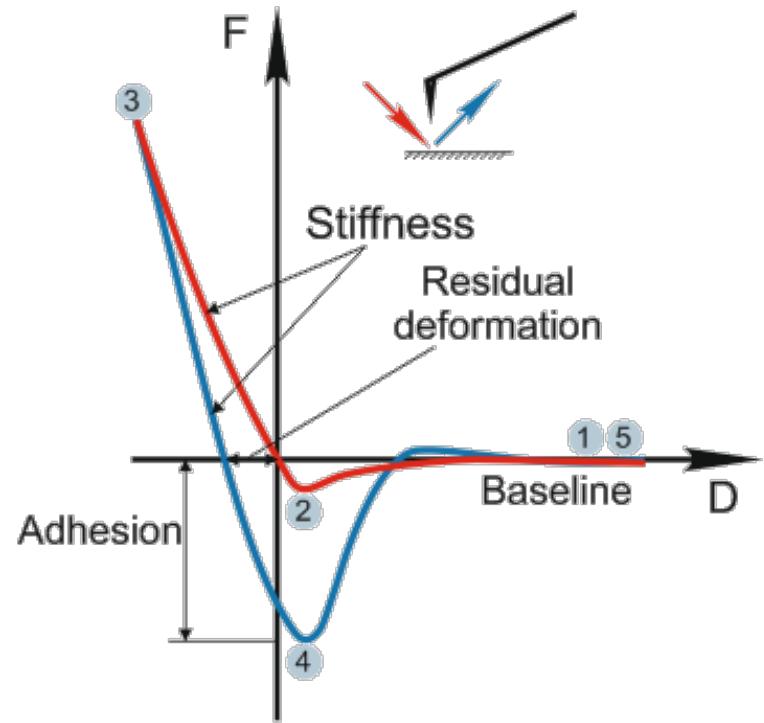
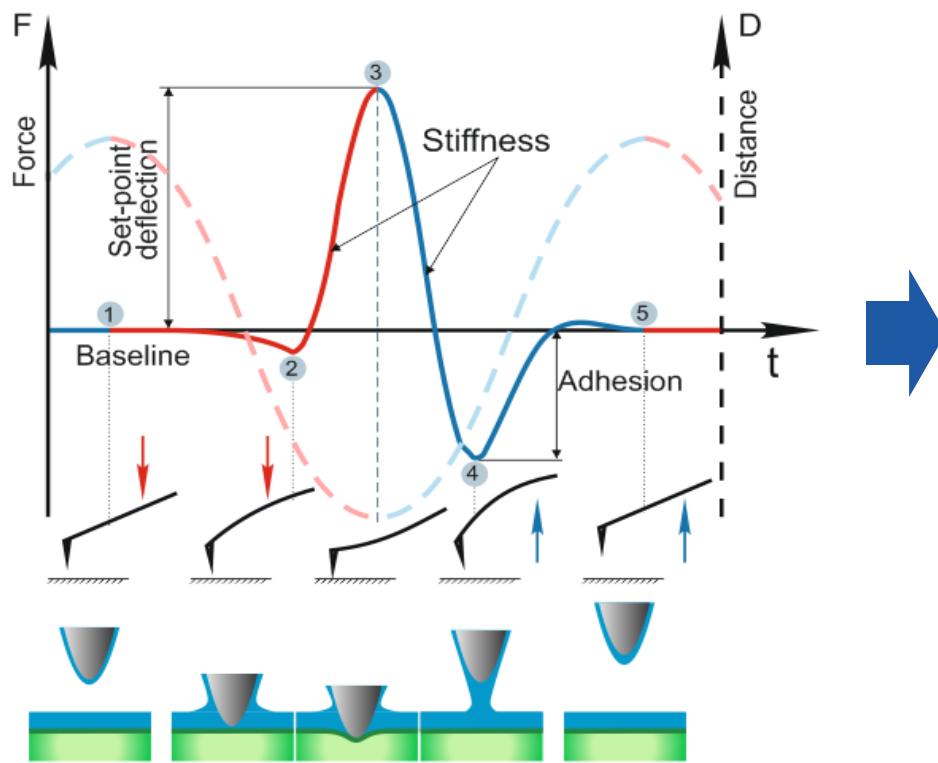


Breaking strength of a single nanofibril is $\sim 120 \text{ nN}$

Wang, Q. & Schniepp, H. Strength of Recluse Spider's Silk Originates from Nanofibrils. *ACS Macro Letters* 7, 1364-1370 (2018).

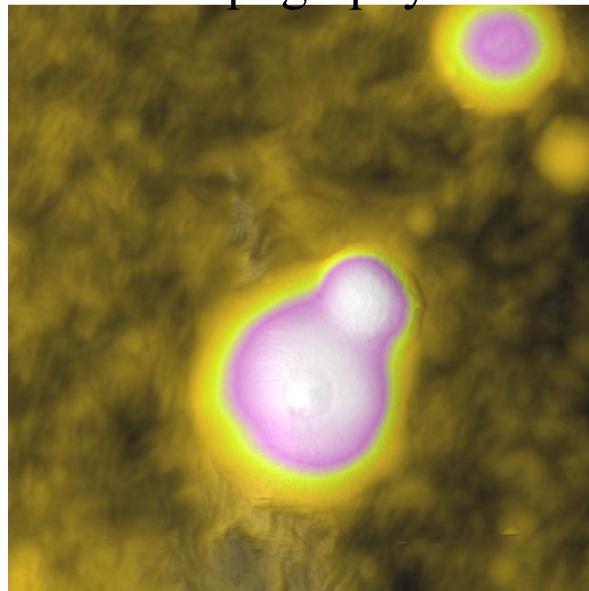
Методика HybriD™

- HybriD mode (HD mode) – scanning technique based on fast force-distance curves measurements with real-time processing of the tip response.

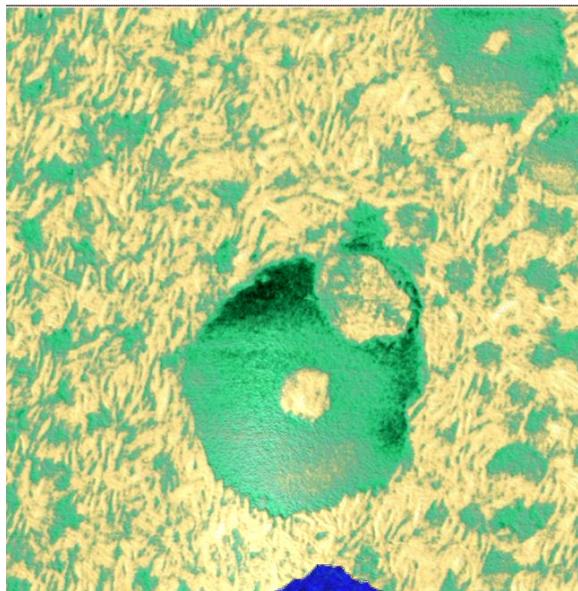


Морфологические и механические исследования полимерных смесей

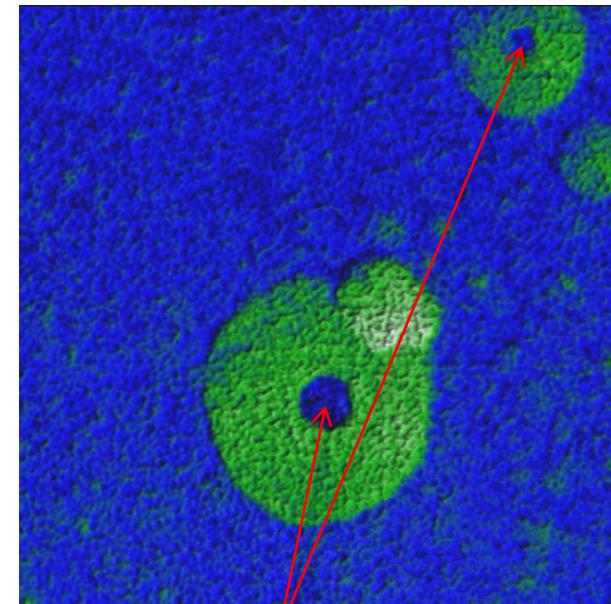
Topography



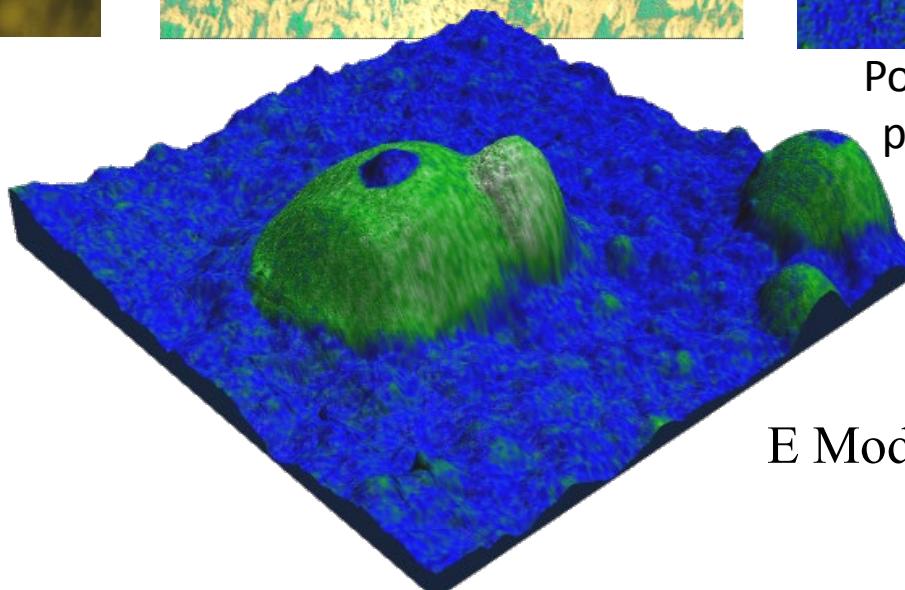
Adhesion



E Modulus

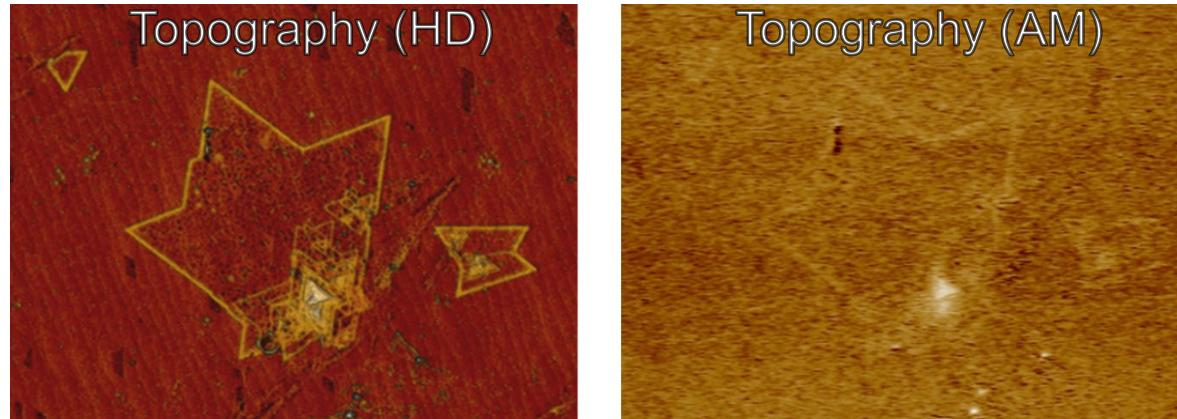


Scan Size:
 $3 \times 3 \mu\text{m}$



E Modulus overlaid over
topography

HybriD в вакууме

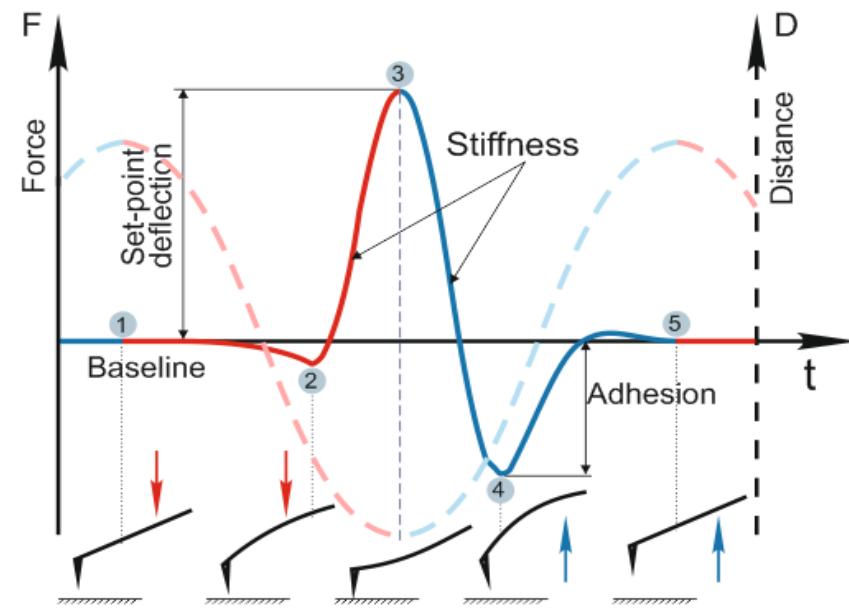


WS₂ monolayers grown on epitaxial graphene measured in vacuum with use of HD and AM modes. The influence of electrostatic forces is demonstrated. Scan size: 14×14 μm

Vacuum setup of
NTEGRA AFM

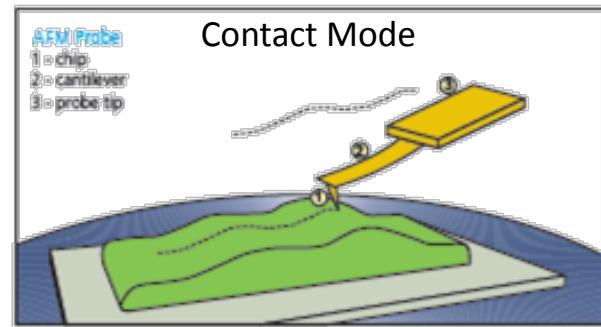


Sample courtesy:
Dr. Cristina Giusca (NPL, UK),
Prof. Mauricio Terrones (PSU, USA)

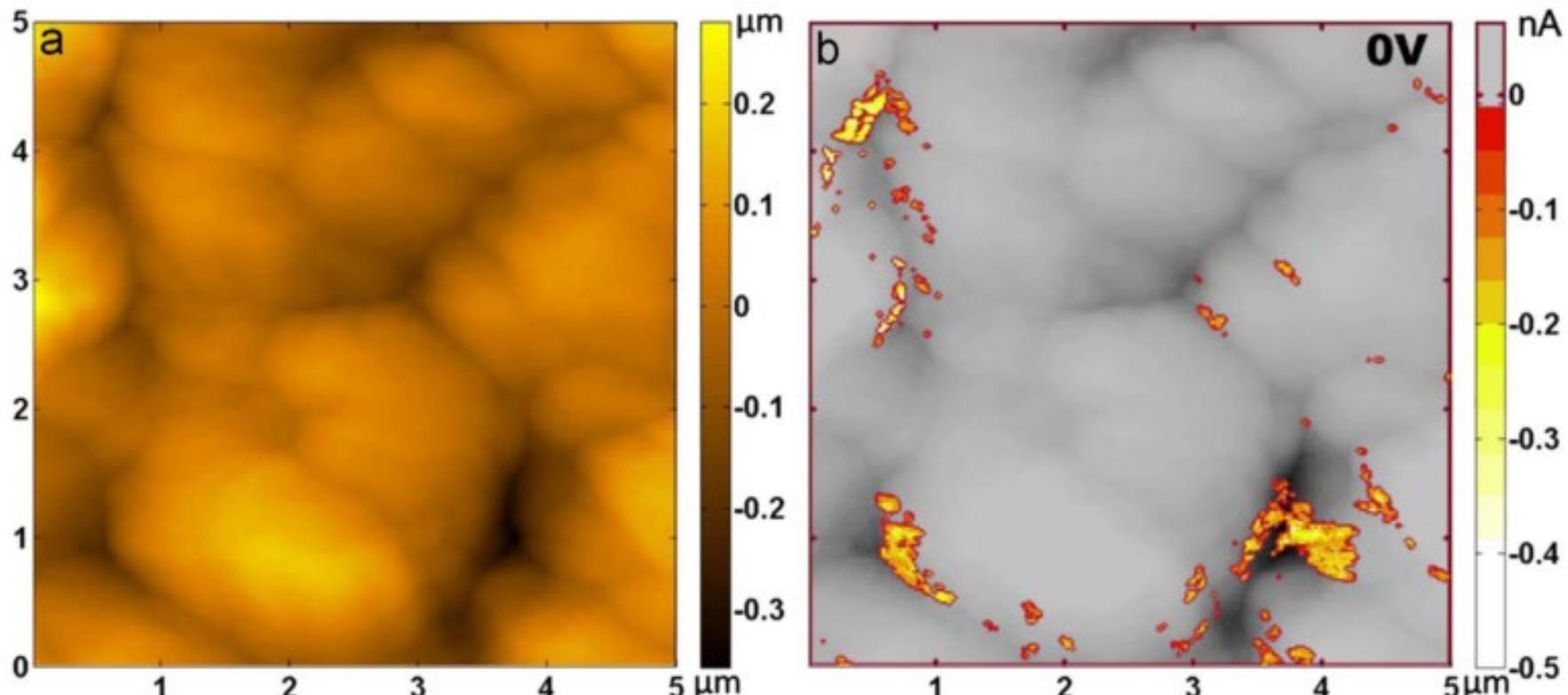


Set-point calculation principle eliminating
electrostatic force gradient

Измерение проводимости (C-AFM)



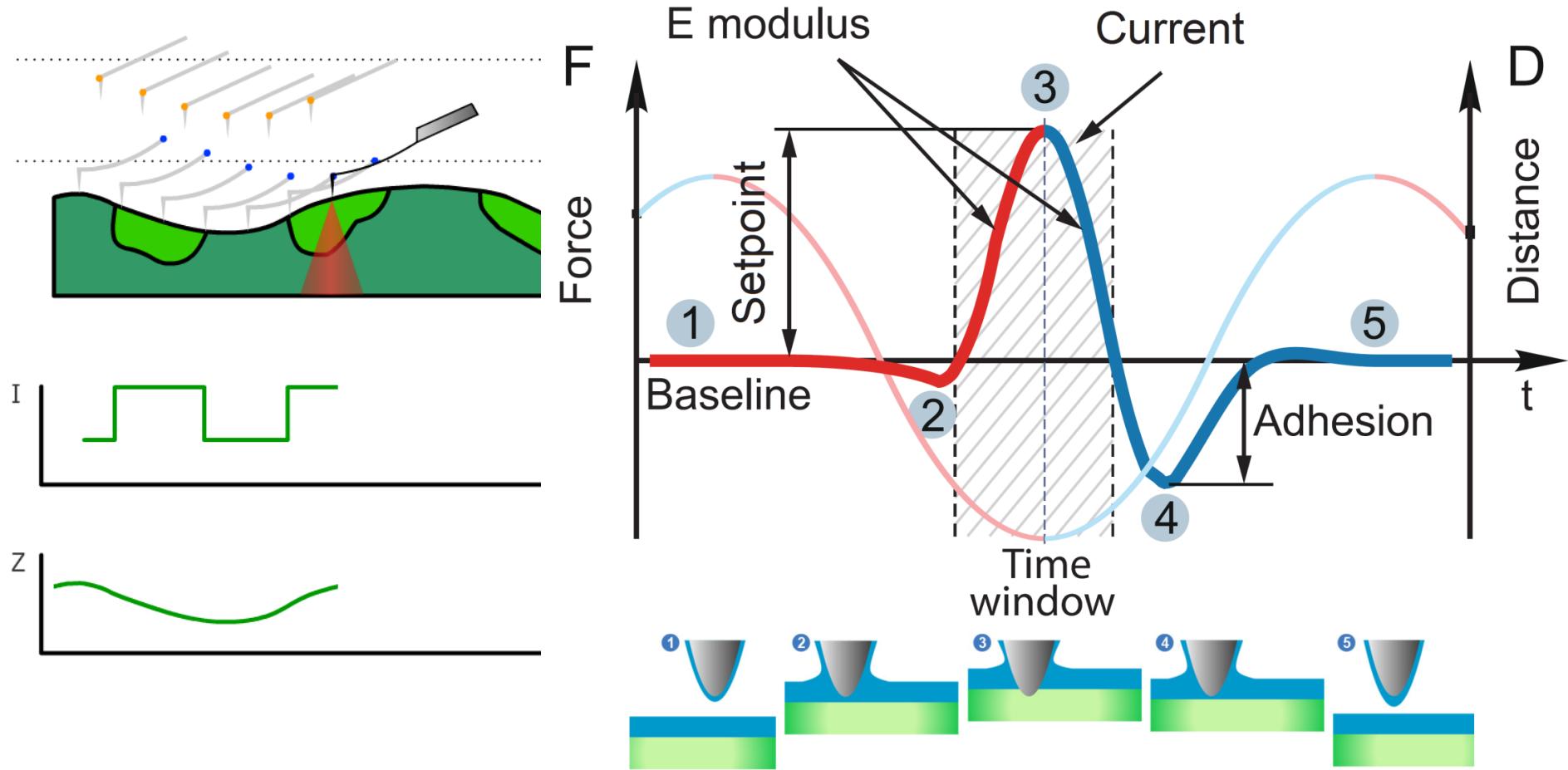
Измерения проводимости границ зерен солнечных батарей Cu₂ZnSnSe₄



(a) AFM topography of the top surface of a CZTSe device. (b) Zero biased photocurrent mapping, under illumination of a defocused 532 nm continuous wave laser with total power of 1mW. The photocurrent mapping is superimposed on the topography in (a) to illustrate the correlation between the position of the photo current and that of the GBs

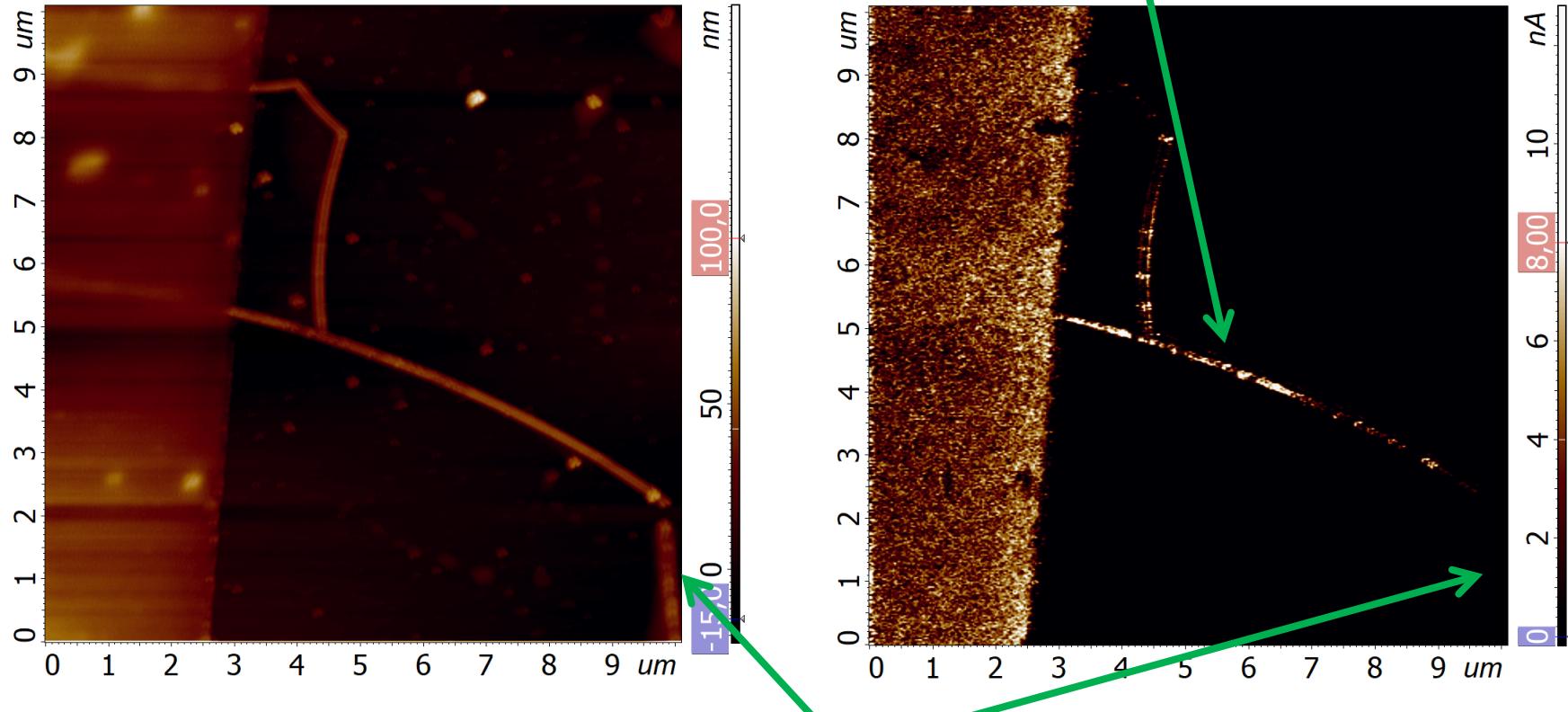
M. Xu, B. Liu, G. Graham and X. Pan, "High resolution characterization of grain boundaries in Cu₂ZnSnSe₄ solar cells synthesized by nanoparticle selenization", *Solar Energy Materials and Solar Cells*, vol. 157, pp. 171-177, 2016.

Измерение проводимости при помощи методики HybriD



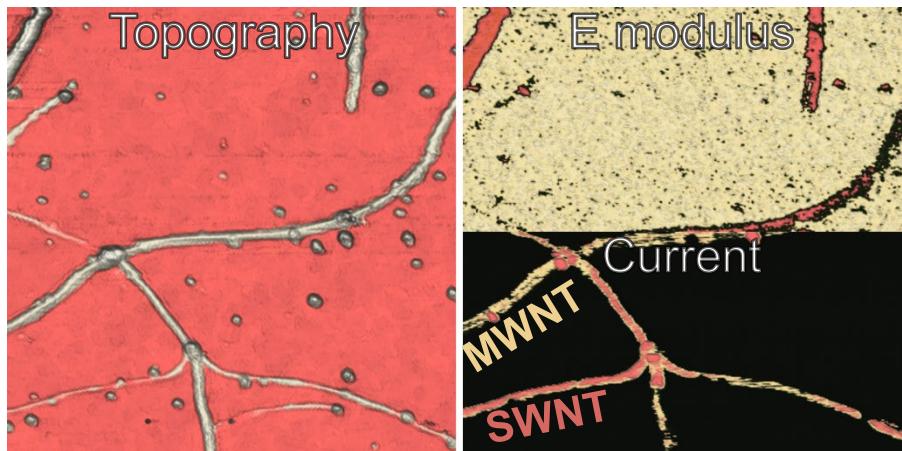
Измерение проводимости серебряных нанотрубок

There is a gradient of current along the nanotube



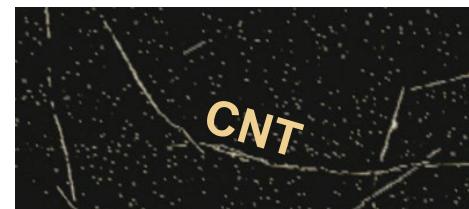
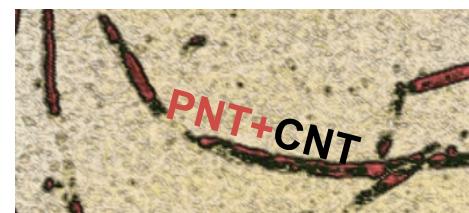
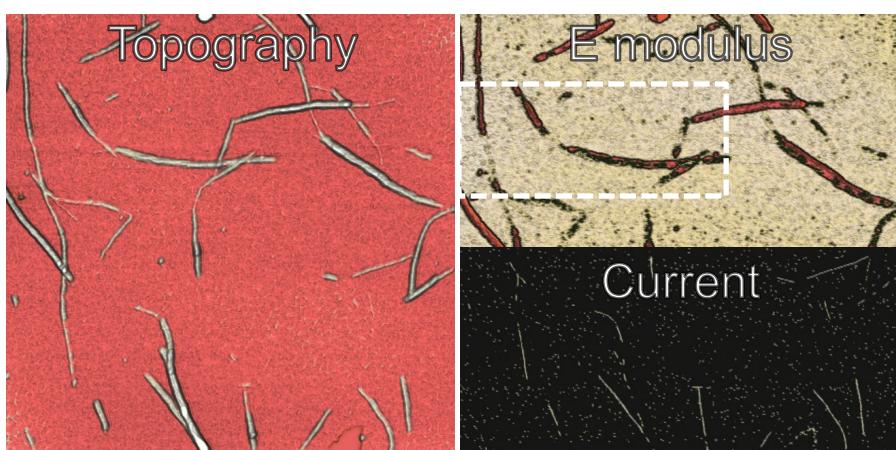
Nanotube is not connected to the electrode

Электрические и механические измерения нанотрубок при помощи HD-CAFM



HD C-AFM study of carbon Nanotubes on Silicon.
Scan size: $1 \times 1 \mu\text{m}$.

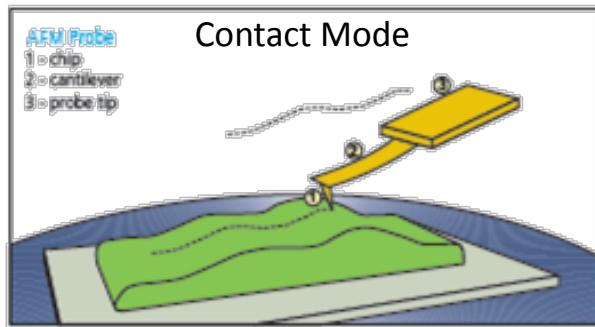
Sample Courtesy: Dr. Irma Kuljanishvili, Saint Louis University, Department of Physics



HD C-AFM study of coupled carbon and peptide Nanotubes. Sample courtesy: Dr. J. Montenegro, University Santiago de Compostela. Scan size: $3 \times 3 \mu\text{m}^1$.

¹ J. Montenegro, C. Vázquez-Vázquez, A. Kalinin, K.E. Geckeler, J.R. Granja, Coupling of carbon and peptide nanotubes, *J. Am. Chem. Soc.* 136 (2014) 2484–2491

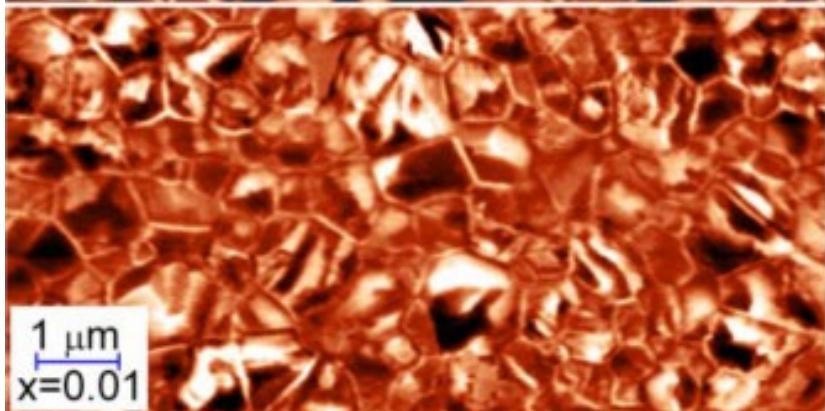
Атомно-силовая микроскопия пьезоотклика (PFM)



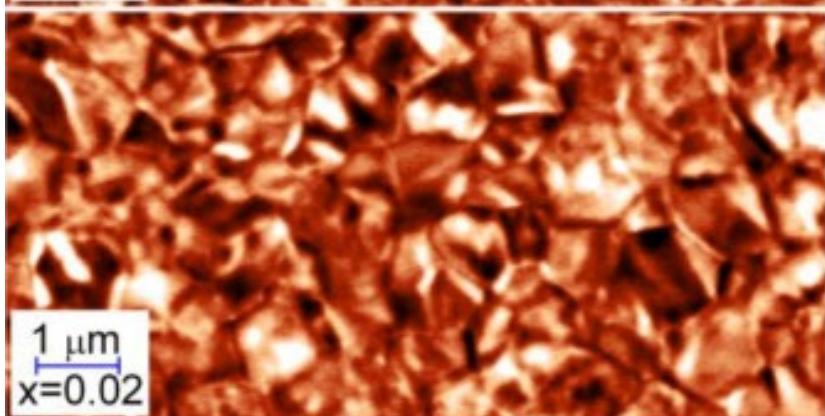
Пьезоэлектрические измерения керамики $\text{Bi}_{0.9}\text{La}_{0.1}\text{FeO}_3$



Vertical PFM images of the $\text{Bi}_{0.9}\text{La}_{0.1}\text{Fe}_{1-x}\text{Nb}_x\text{O}_3+x$ ceramics. An $A \cos \phi$ signal was recorded. Here, A is the amplitude of the measured vibration proportional to the effective longitudinal piezoelectric coefficient and ϕ is the phase shift determining the direction of polarization (the bright and dark regions correspond to polarization vectors directed to the free surface and to the bottom electrode, respectively)



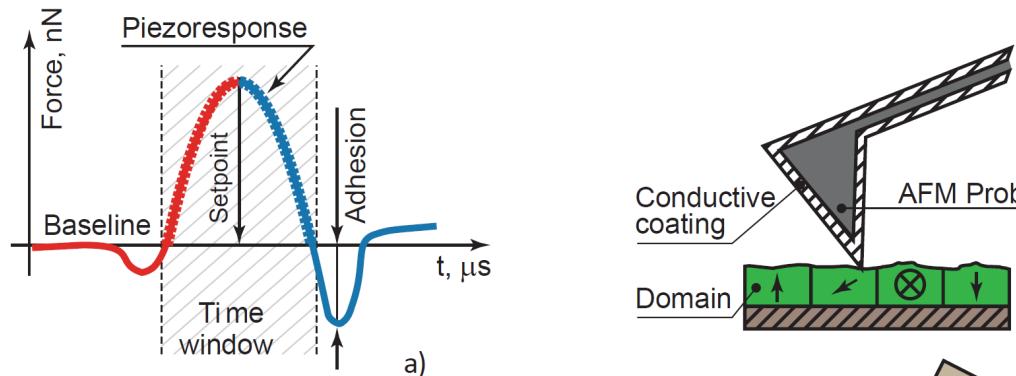
PFM Studies confirm the effect of Effect of Nb doping



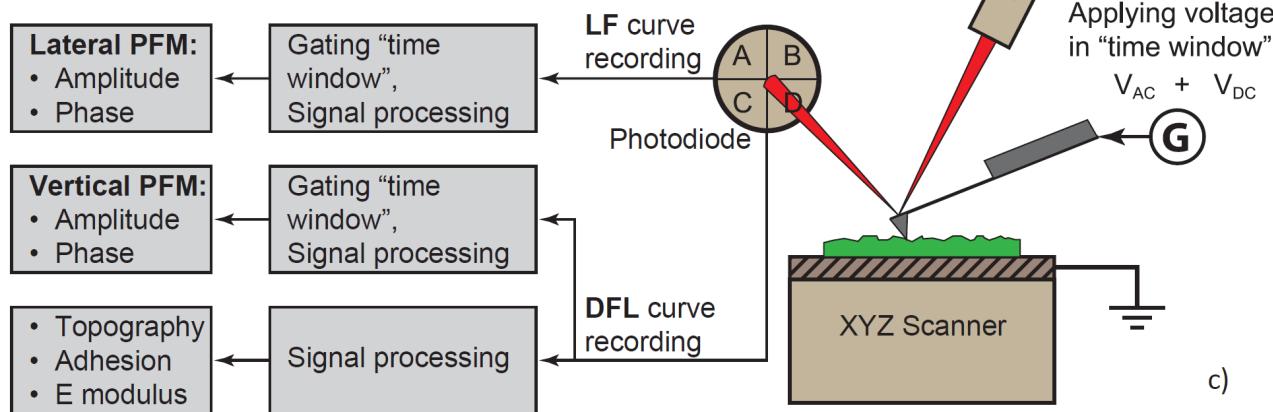
B. Stojadinović, B. Vasić, D. Stepanenko, N. Tadić, R. Gajić and Z. Dohčević-Mitrović,
"Variation of electric properties across the grain boundaries in BiFeO_3 film", *Journal of Physics D: Applied Physics*, vol. 49, no. 4, p. 045309, 2015.

HD PFM

In HD PFM an AC voltage is applied to the conductive coating of the AFM cantilever when the tip comes in contact with the sample during each fast force spectroscopy cycle.



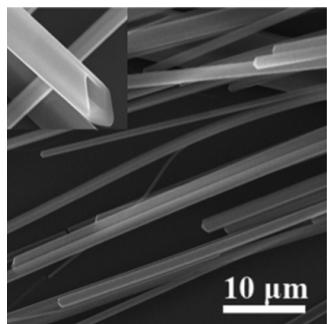
b)



c)

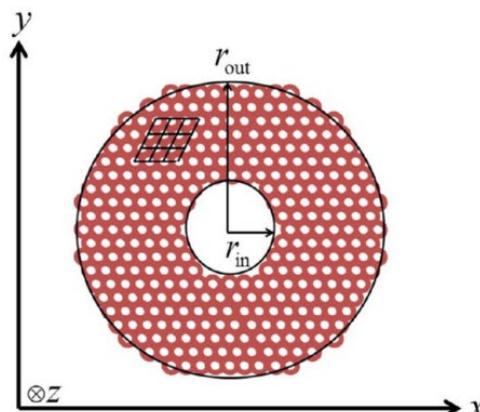
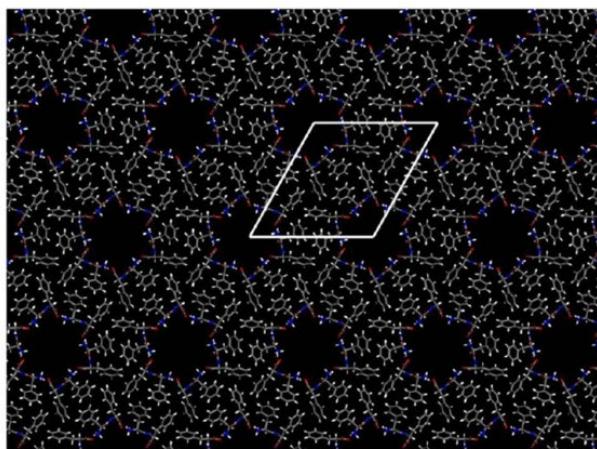
- HD PFM working principle: a) an idealized temporal deflection curve during an oscillatory cycle, b) tip-sample interaction in “time window”, c) measurement scheme

Электромеханические исследования нанотрубок дифенилаланина

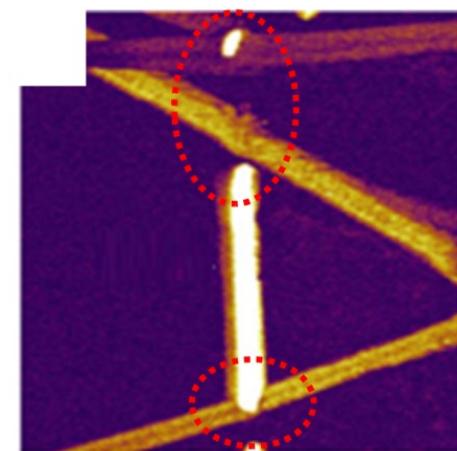


$$d_{15} = 60 \text{ pm/V}^1$$

E modulus = 19÷32 GPa



- Molecular structure of diphenylalanine peptide nanotubes¹



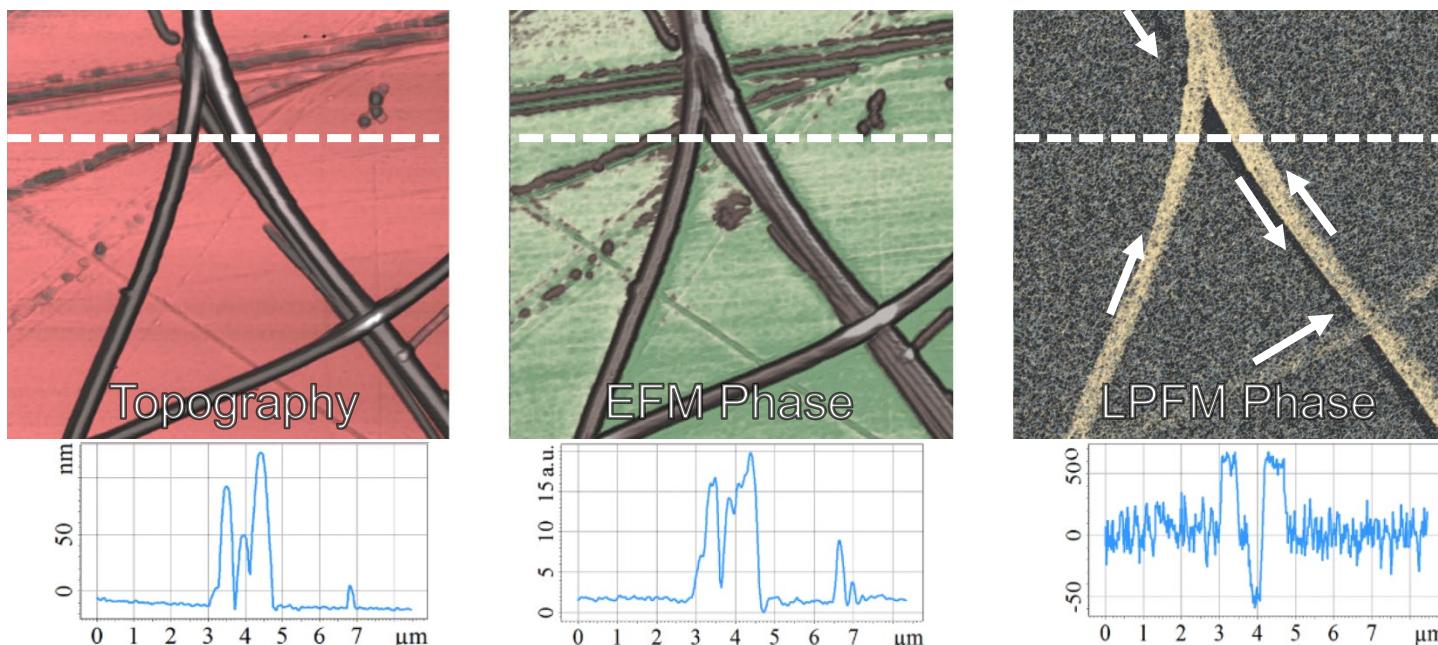
- Contact PFM image²

¹Kholkin, A., Amdursky, N., Bdikin, I., Gazit, E., & Rosenman, G. (2010) ACS nano, 4(2), 610-614.

²Ivanov, M., Kopyl, S., Tofail, S. A., Ryan, K., Rodriguez, B. J., Shur, V. Y., & Kholkin, A. L. (2016) In Electrically Active Materials for Medical Devices (pp. 149-166).

Электромеханические исследования нанотрубок дифенилаланина

For the first time HD PFM mode allowed non-destructive piezoresponse study of diphenylalanine peptide nanotubes – a very prospective material for biomedical applications.



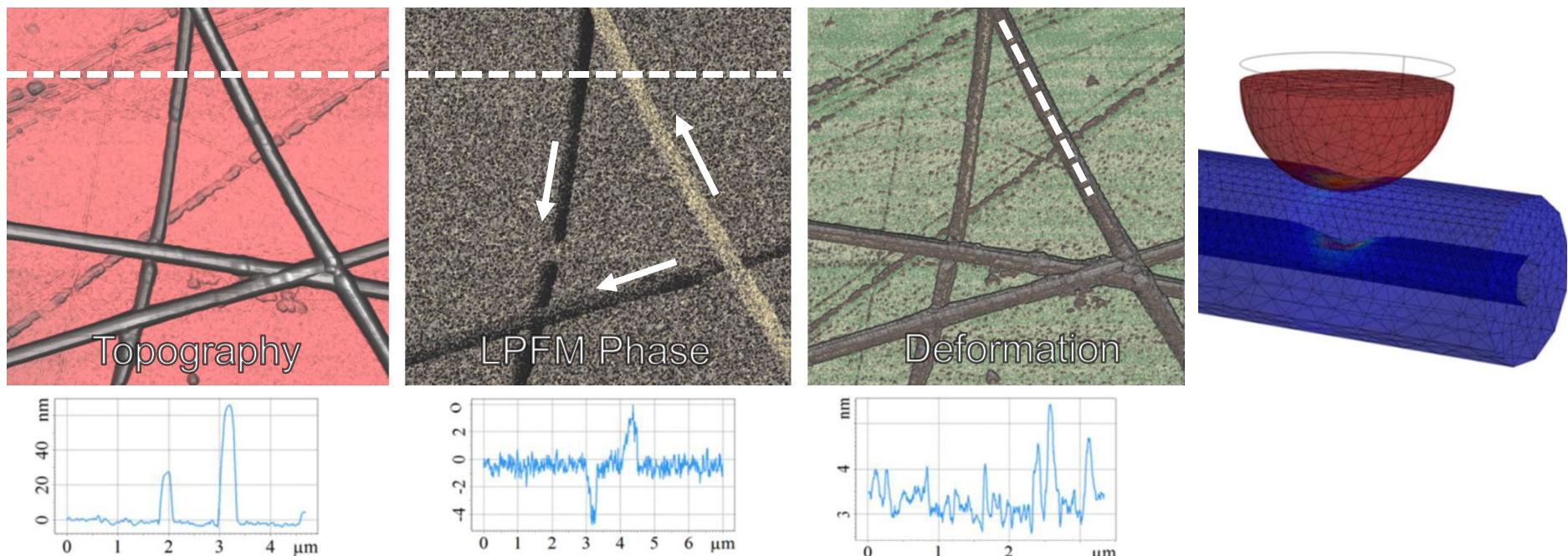
Non-destructive electromechanical study of diphenylalanine peptide nanotubes. Scan size: $8 \times 8 \mu\text{m}$, nanotubes diameter: $30 \div 150 \text{ nm}$.

Sample courtesy: Dr. A. Kholkin, University of Aviero

A. Kalinin, V. Atepaliukhin, O. Pakhomov, A. Kholkin and A. Tselev, "An atomic force microscopy mode for nondestructive electromechanical studies and its application to diphenylalanine peptide nanotubes", *Ultramicroscopy*, vol. 185, pp. 49-54, 2018.

Электромеханические исследования нанотрубок дифенилаланина

- For the first time HD PFM mode allowed non-destructive piezoresponse study of diphenylalanine peptide nanotubes – a very prospective material for biomedical applications.

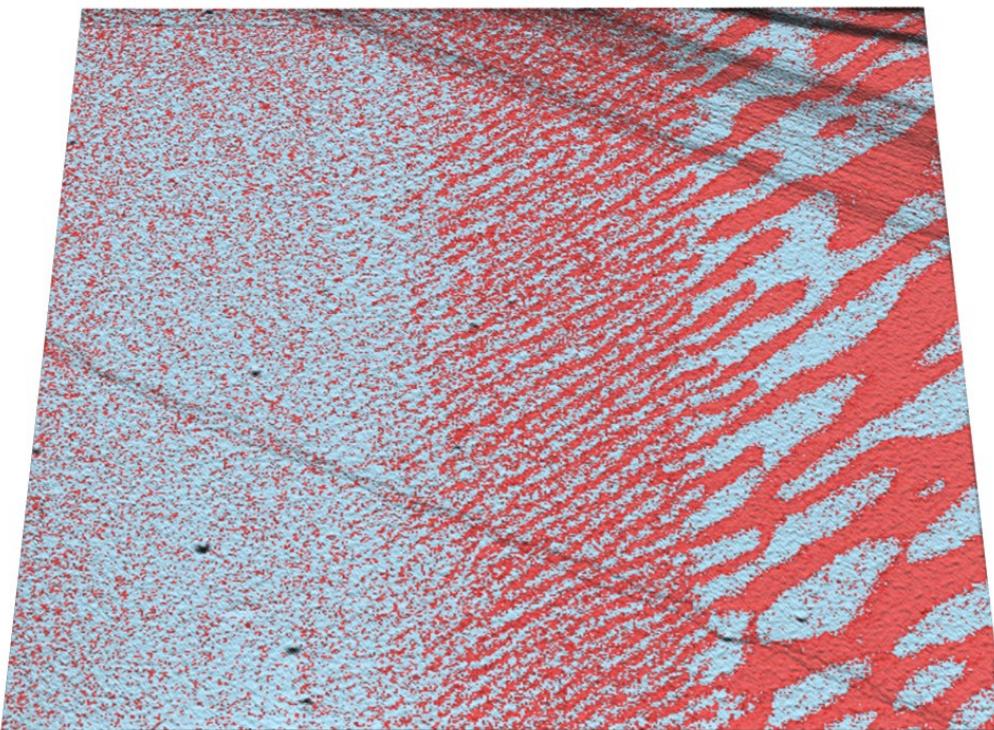


- Non-destructive electromechanical study of diphenylalanine peptide nanotubes. Scan size: $7 \times 7 \mu\text{m}$, nanotubes diameter: $70 \div 100 \text{ nm}^1$. Sample courtesy: Dr. A. Kholkin, University of Aviero

A. Kalinin, V. Atepalkhin, O. Pakhomov, A. Kholkin and A. Tselev, "An atomic force microscopy mode for nondestructive electromechanical studies and its application to diphenylalanine peptide nanotubes", *Ultramicroscopy*, vol. 185, pp. 49-54, 2018.

Электромеханические исследования фазового перехода триглицисульфата при нагреве в режиме реального времени

50 °C
49 °C
48 °C

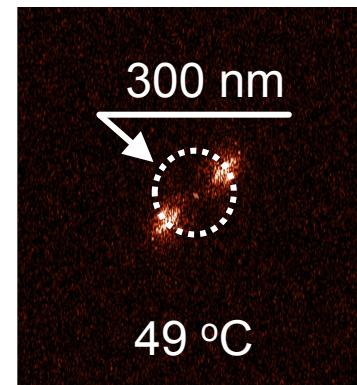


RT÷300 °C

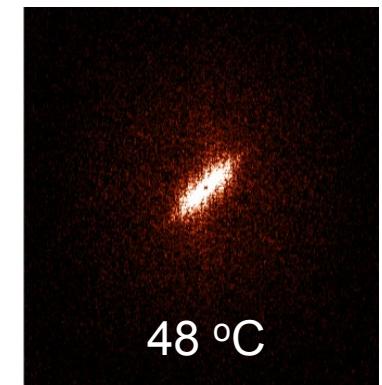


-30÷120 °C

NT-MDT S.I. accessories for sample temperature control



49 °C

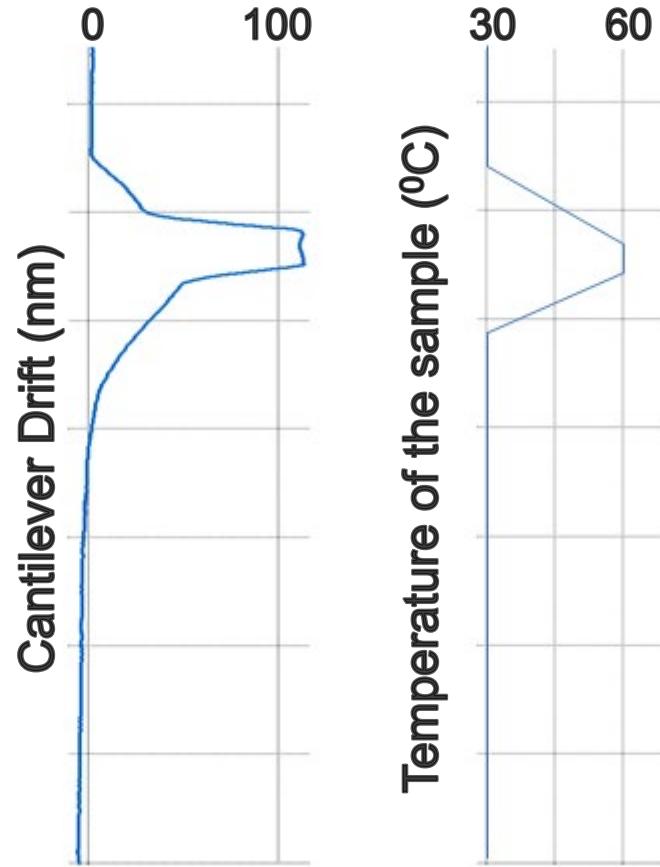
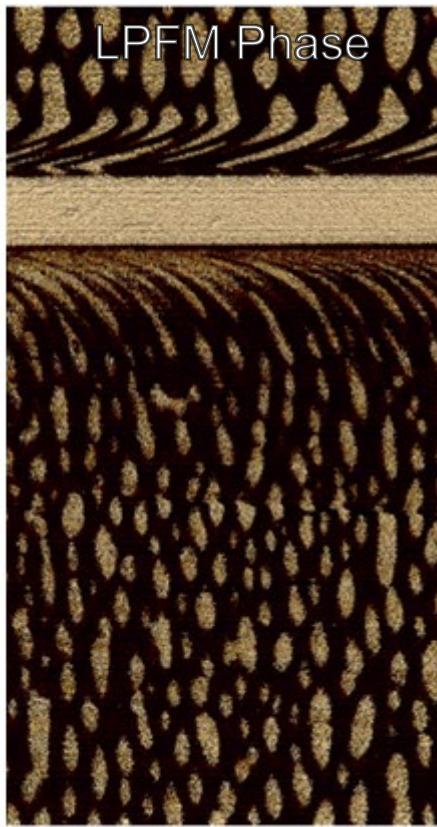
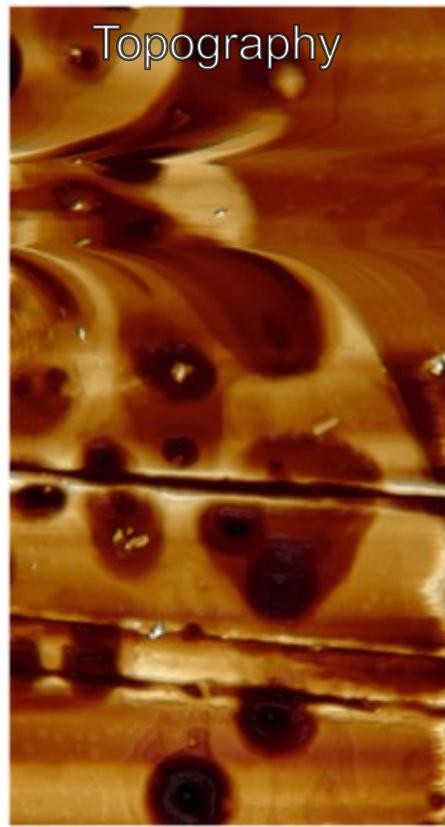


48 °C

In-situ HD PFM study of second-order phase transition of triglycine sulfate crystal. Scan size 15×15 μm. Sample courtesy: Dr. R. Gainutdinov, IC RAS

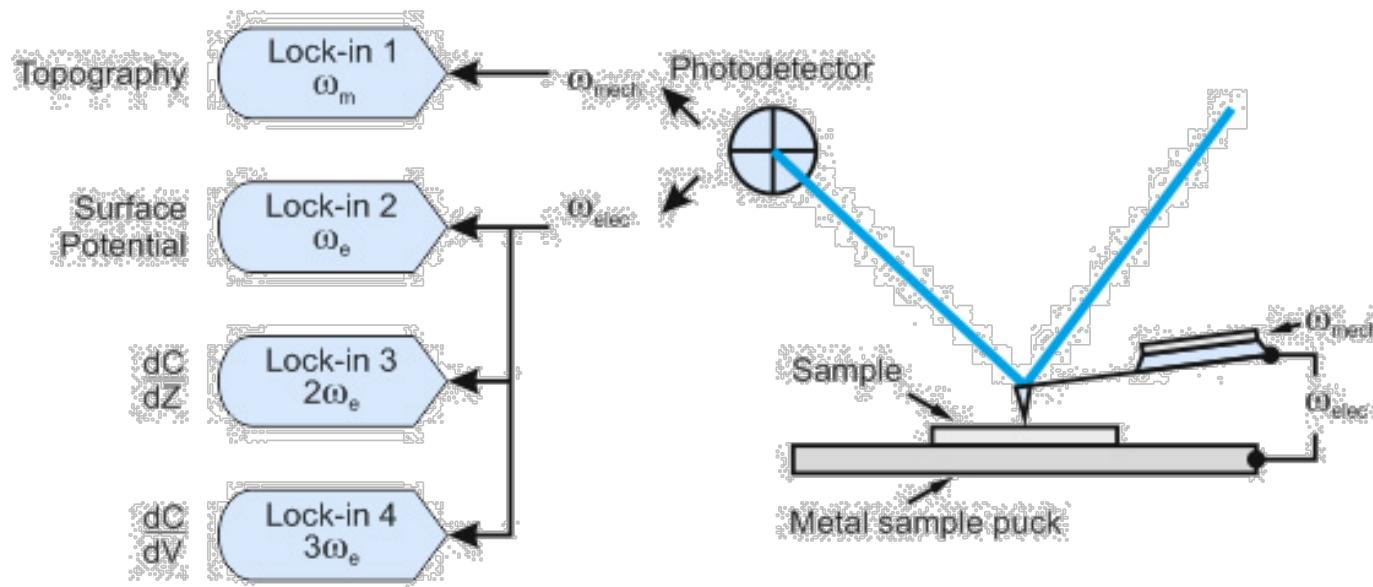
HD PFM

Continuous PFM studies under variable temperature
>0.1 °C/sec temperature change



In-situ HD PFM study of second-order phase transition of triglycine sulfate crystal. Scan size 15×15 μm. Sample courtesy: Dr. R. Gainutdinov, IC RAS

Кельвин-зондовая микроскопия



Electrostatic interaction between probe and sample

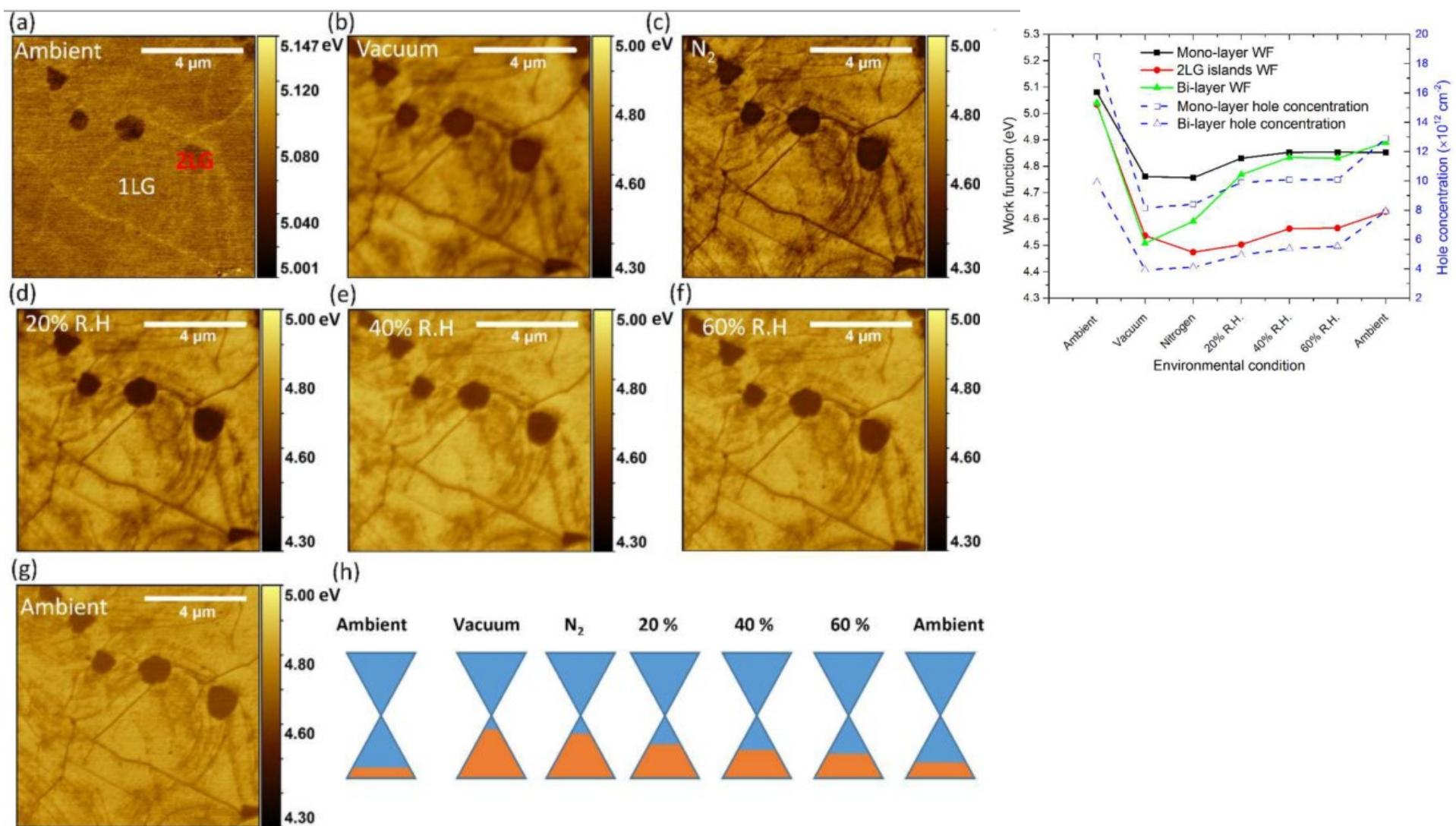
$$F_z = F_{z,DC} + F_{z,\omega} + F_{z,2\omega}$$

$$F_{z,DC} = - \left[\frac{1}{2} \times \left((U_0 - \varphi(x, y))^2 + \frac{1}{2} \times U_1^2 \right) \right] \times \frac{\partial C}{\partial Z}$$

$$F_{z,\omega} = - \left[(U_0 - \varphi(x, y)) \times U_1 \times \sin(\omega t) \right] \times \frac{\partial C}{\partial Z}$$

$$F_{z,2\omega} = \left[\frac{1}{4} \times U_1^2 \times \cos(2\omega t) \right] \times \frac{\partial C}{\partial Z}$$

Исследования работы выхода графена при различной влажности

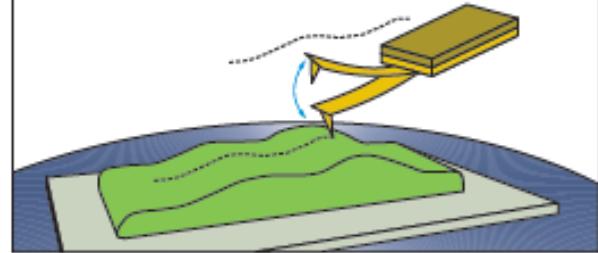


C. Melios, A. Centeno, A. Zurutuza, V. Panchal, C. Giusca, S. Spencer, S. Silva and O. Kazakova, "Effects of humidity on the electronic properties of graphene prepared by chemical vapour deposition", *Carbon*, vol. 103, pp. 273-280, 2016.

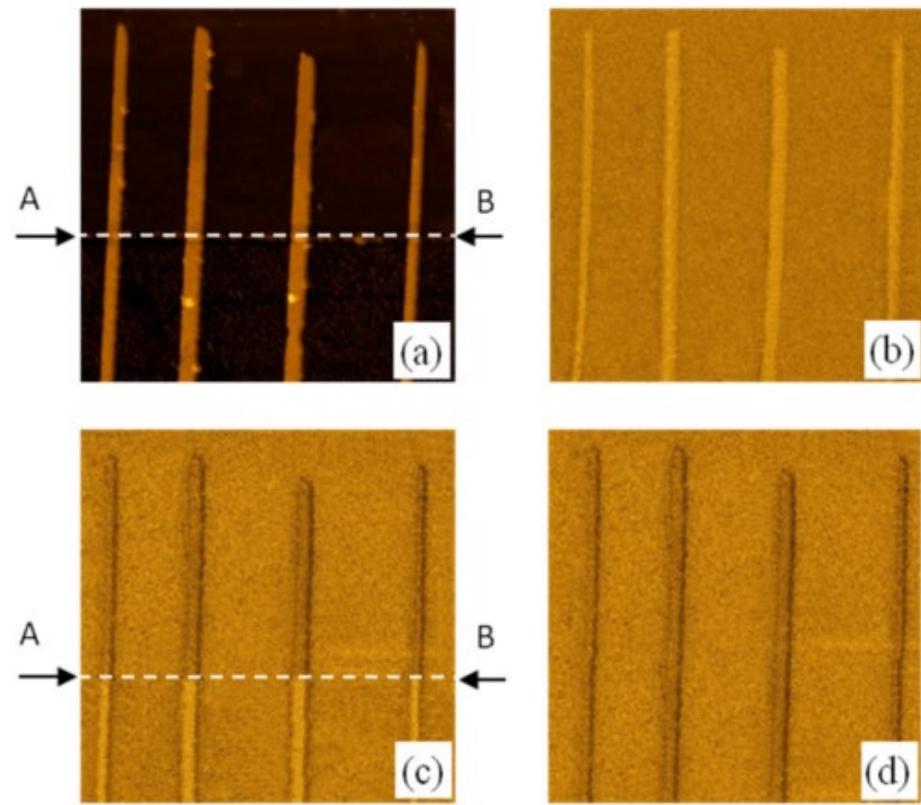
Магнитно-силовая микроскопия (MFM)



Tapping Mode



МСМ исследования нанотрубок Co/Pt при приложении разных магнитных полей



NTEGRA AFM Setup
with in-plane
external magnet



The sequential stages of remagnetization for Co/Pt NWs partly covered by Co capping layer.

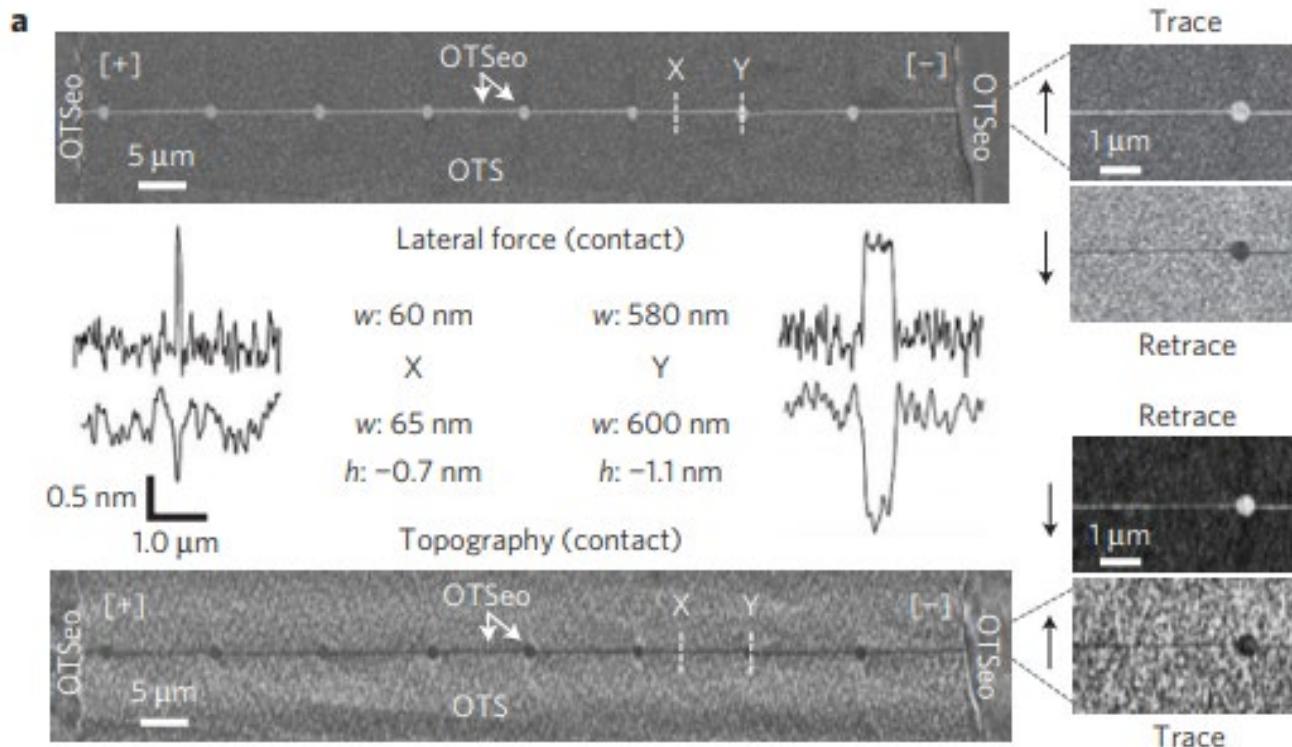
(a) The AFM image of the sample with Co/Pt NWs. The area below line A-B is covered by Co (1.3 nm). The frame sizes are $1.5 \mu\text{m} \times 1.5 \mu\text{m}$. The MFM contrast is normalized to the maximum. The border of Co capping layer is shown by arrows and dashed line; (b) The MFM image of up-magnetized sample; (c) The MFM image of partly remagnetized NWs after applying of 150 Oe reversed magnetic field; (d) The MFM image of down-magnetized NWs in the field of 200 Oe. The frame sizes are $1.5 \mu\text{m} \times 1.5 \mu\text{m}$. The MFM contrast is normalized to the maximum.

O. Ermolaeva, N. Gusev, E. Skorohodov, Y. Petrov, M. Sapozhnikov and V. Mironov,
"Magnetic Force Microscopy of Nanostructured Co/Pt Multilayer Films with Perpendicular
Magnetization", *Materials*, vol. 10, no. 9, p. 1034, 2017.

Нанолитография



Нанолитография на монослоях октадецлтрихлорсиана



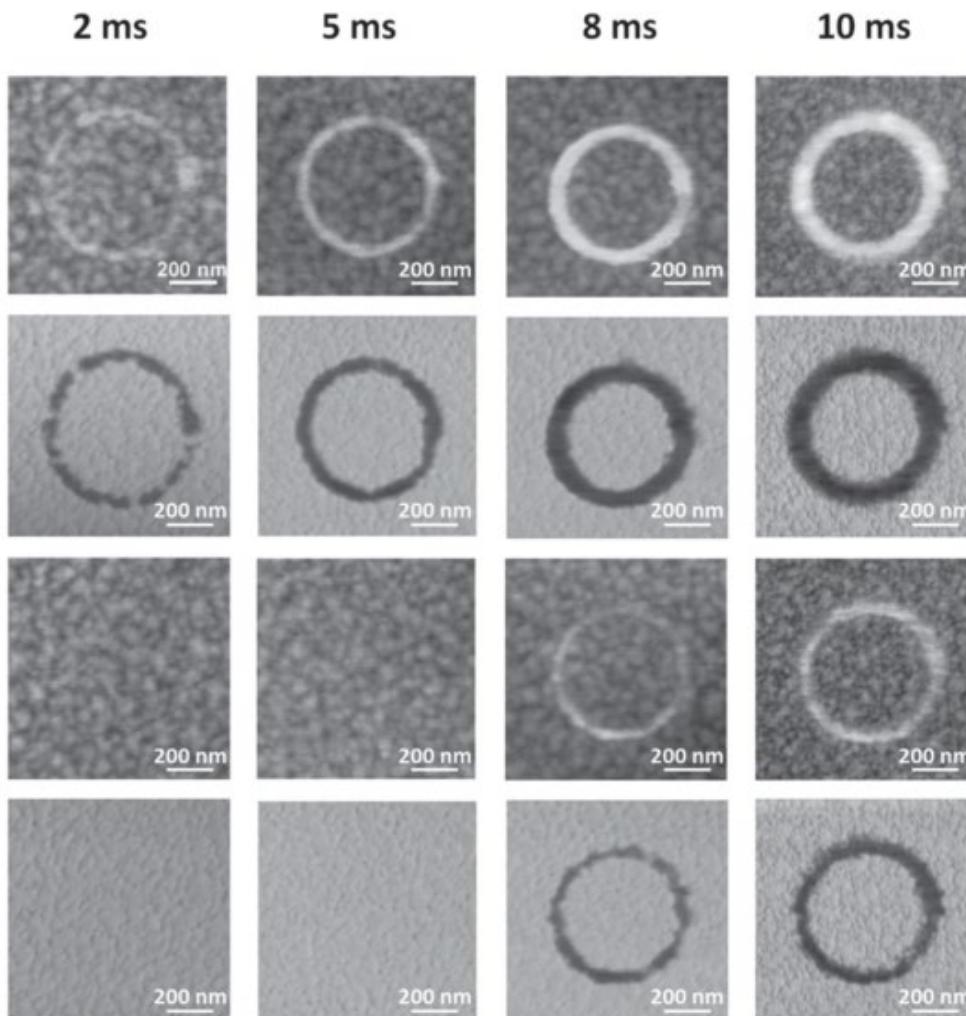
Experimental results obtained with the ion-conducting macro–micro–nano-channel.

AFM images of the OTSeo@OTS nano–micro-channel constriction connecting two large OTSeo@OTS macro-channels with a total area of 2.27 cm^2 taken after the acquisition of all electrical data from this specimen.

J. Berson, D. Burshtain, A. Zeira, A. Yoffe, R. Maoz and J. Sagiv, "Single-layer ionic conduction on carboxyl-terminated silane monolayers patterned by constructive lithography", *Nature Materials*, vol. 14, no. 6, pp. 613-621, 2015.

Обратимая нанолитография на полипирроловых пленках

Writing /
Erasing time



Comparison of the writing and erasing processes using different operation times. The size of each image is $1 \mu\text{m} \times 1 \mu\text{m}$. potentiostatically

H. Liu, S. Hoeppener and U. Schubert, "Reversible Nanopatterning on Polypyrrole Films by Atomic Force Microscope Electrochemical Lithography", *Advanced Functional Materials*, vol. 26, no. 4, pp. 614-619, 2015.



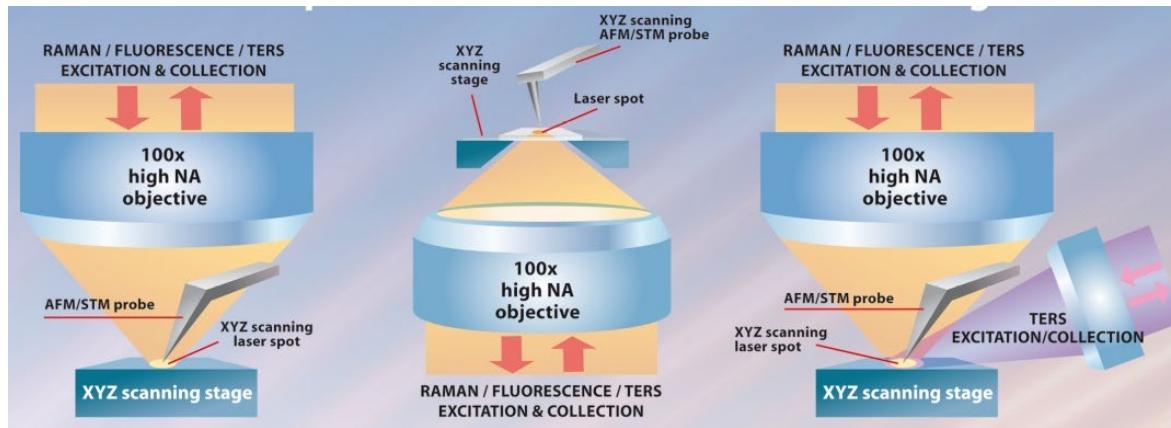
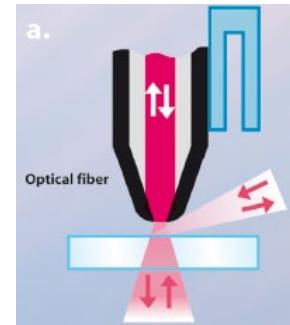
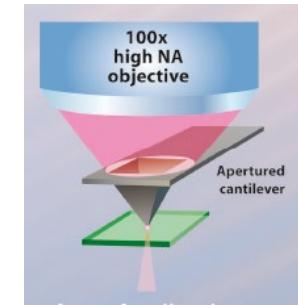
Комбинация АСМ с
оптическими
методиками

Комбинация АСМ с оптическими методиками

NTEGRA SPECTRA

1998-2018

более **20** лет опыта



ИНТЕГРА СПЕКТРА II



Комбинация АСМ с рамановской спектроскопией



AFM: Force modulation
(elastic properties)



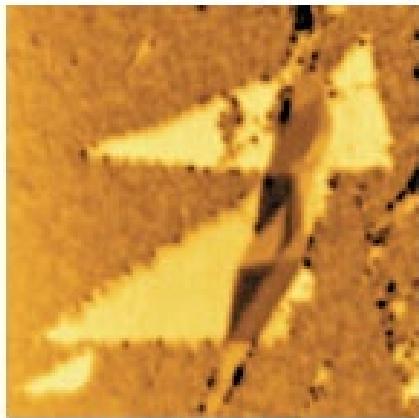
AFM: Electrostatic force (charge distribution)



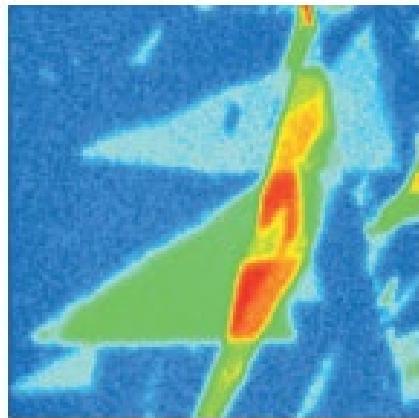
AFM: Kelvin probe microscopy
(surface potential)



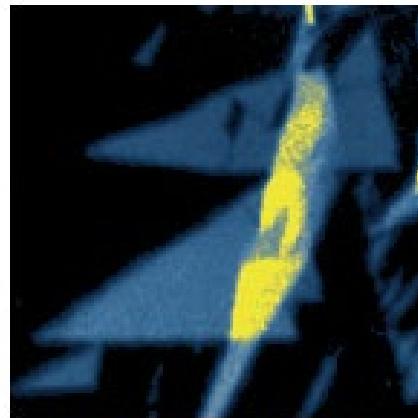
AFM: Lateral force (friction)



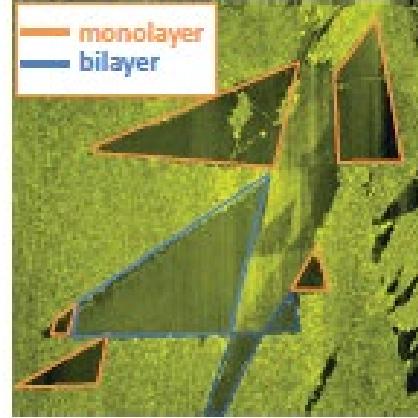
Rayleigh light intensity
(473 nm laser)



Confocal Raman map:
G-band intensity



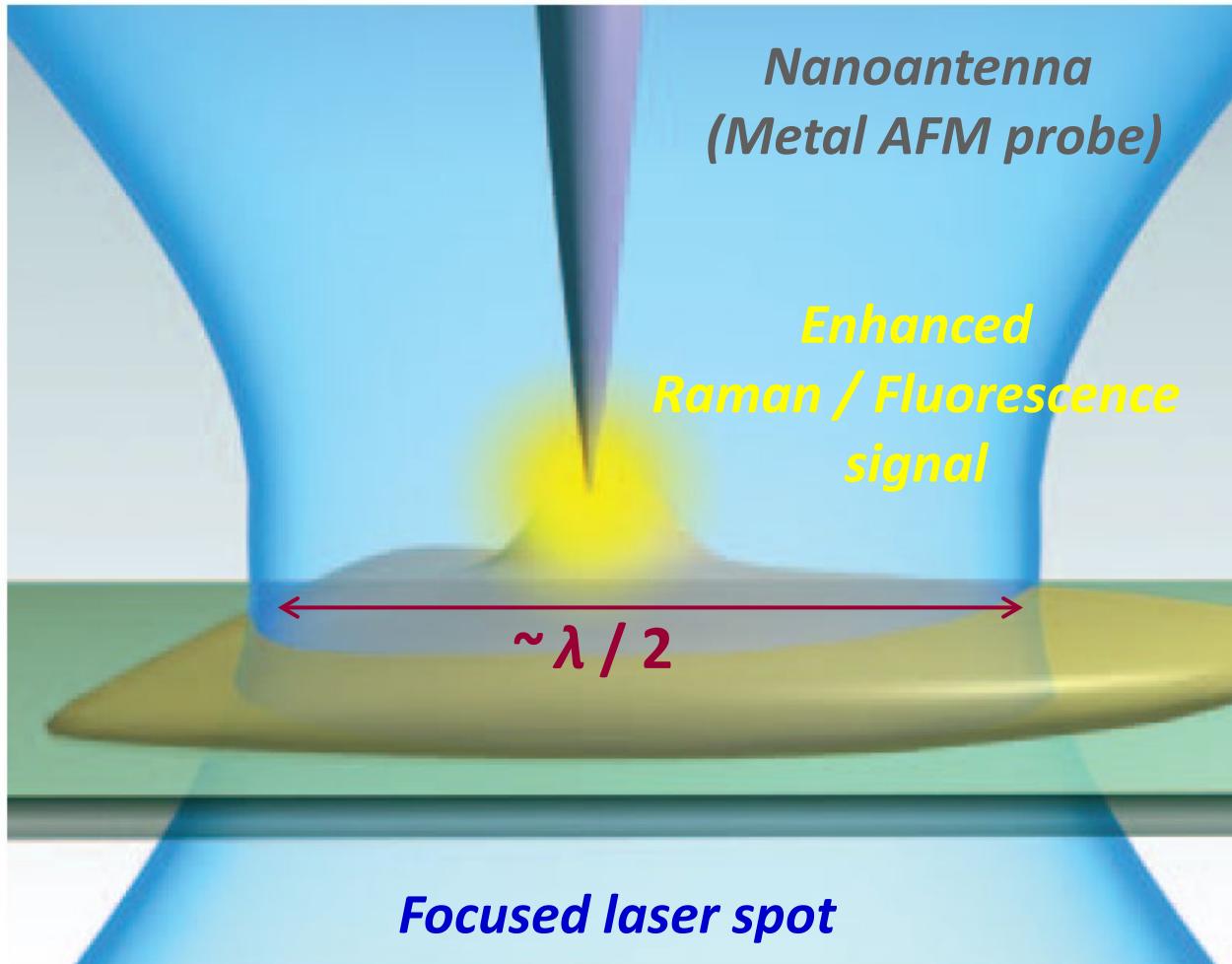
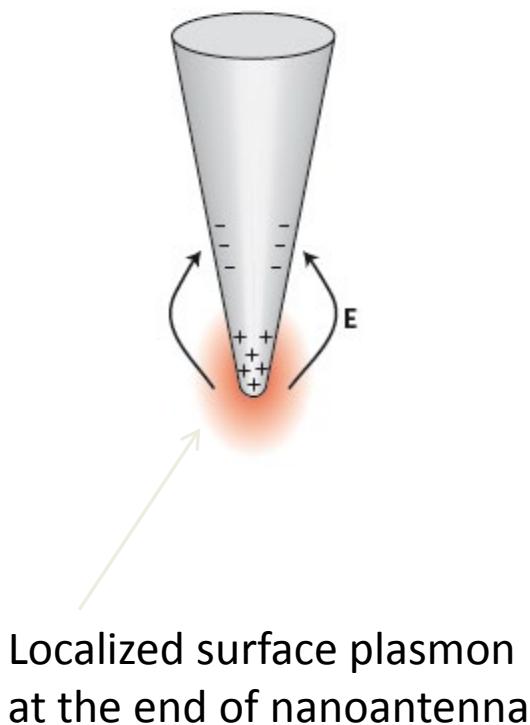
Confocal Raman map:
2D (G') band mass center



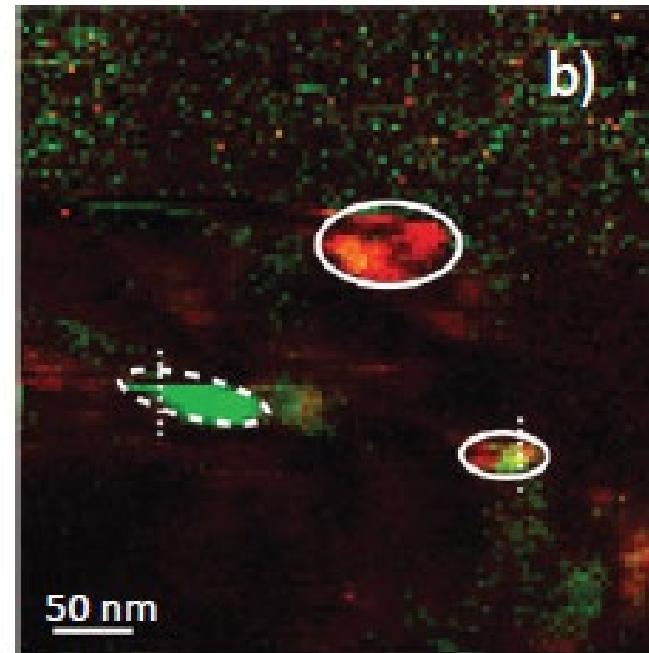
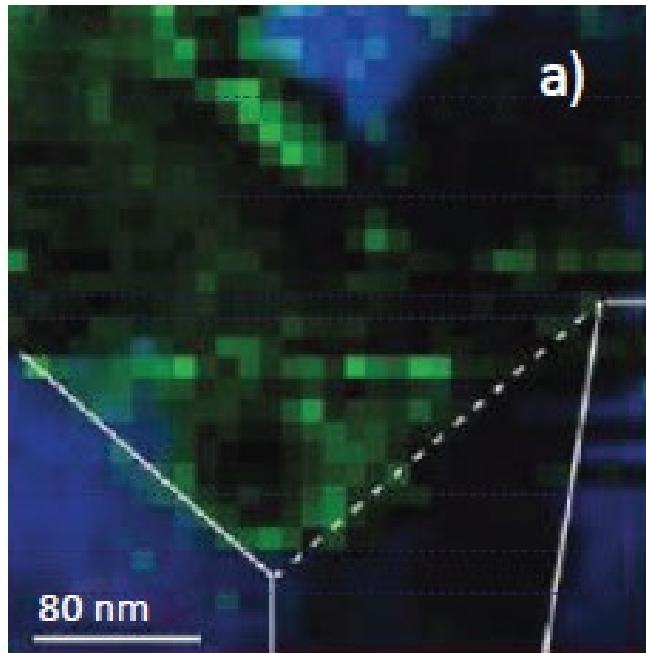
AFM: Height (topography)
Size: 30×30 μm. Substrate: gold

Зондово-усиленное комбинационное рассеяние света (TERS)

Raman/Fluorescence microscopy with subwavelength spatial resolution

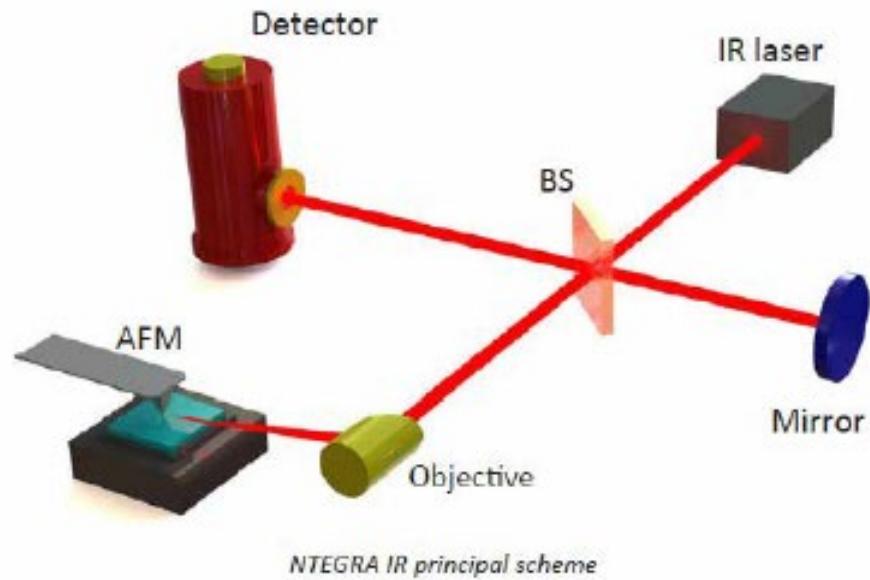
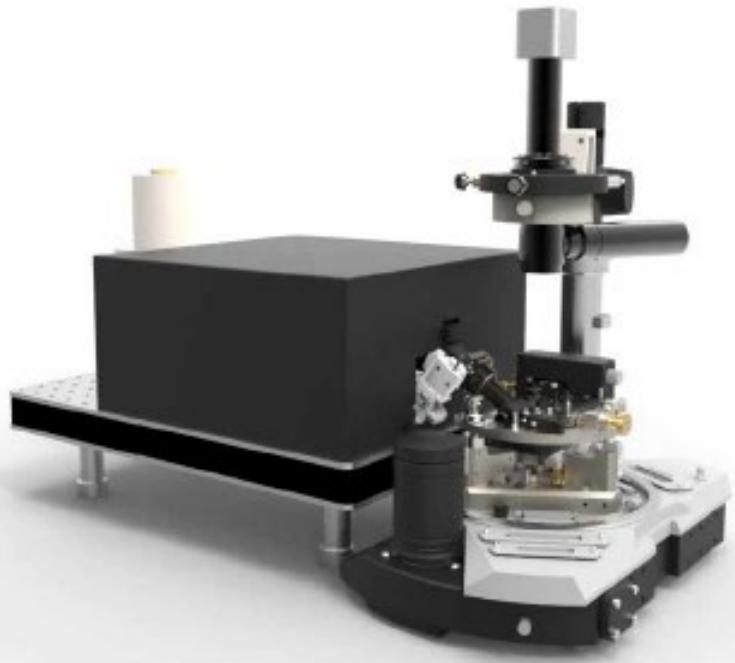


Дефекты в графене с разрешением лучше дифракционного предела



(a) TERS maps of single layer CVD Graphene on copper substrate. Green color: areas of pristine graphene (2D band intensity). Blue color: CH-terminated graphene areas (CHbands intensity). (b) TERS map of mechanically exfoliated single layer graphene on Au substrate. Green color: 2D band intensity. Red color: Dband intensity (areas with strong defects). **Resolution of all Raman maps is <12 nm.**

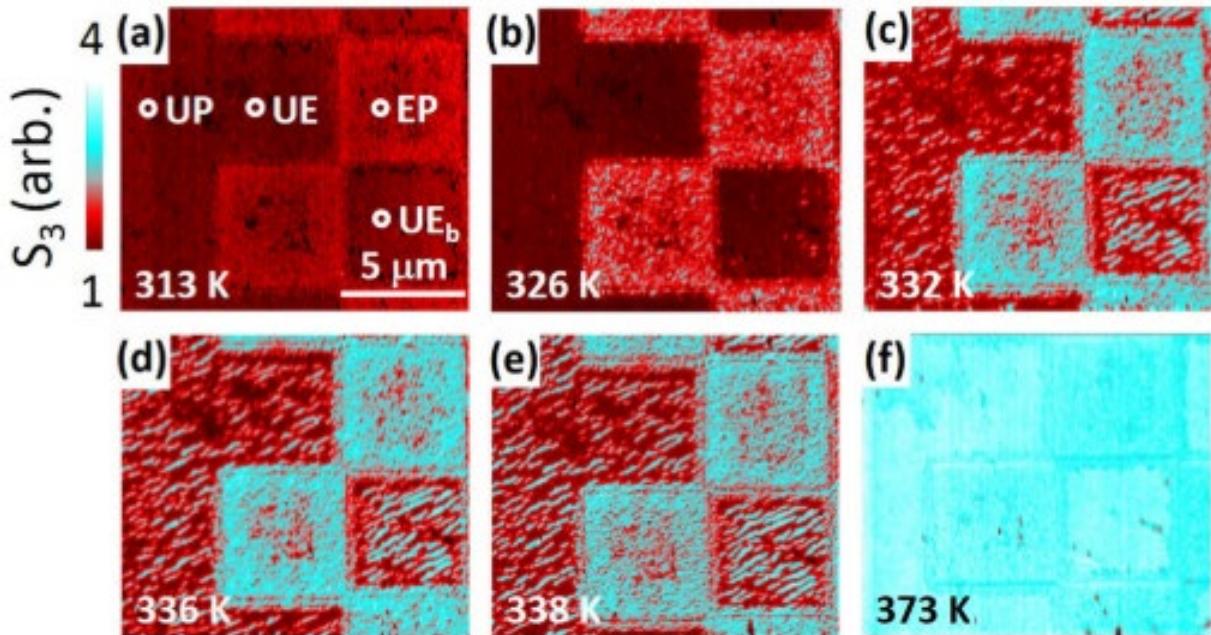
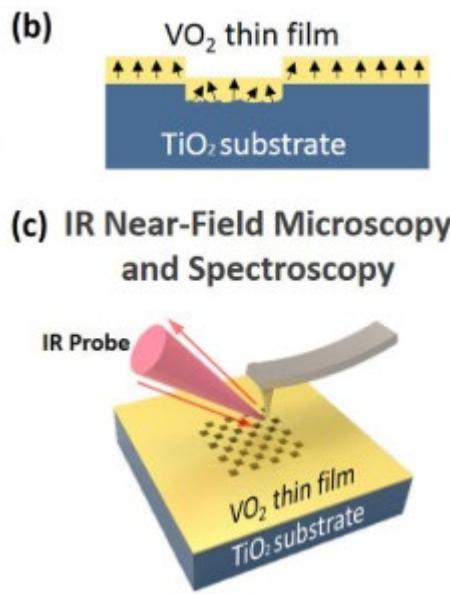
NTEGRA Nano IR: ИК р-СБОМ



NTEGRA IR principal scheme

- IR s-SNOM microscopy and spectroscopy with 10 nm spatial resolution
- Wide spectral range of operation: 3-12 μm
- Incredibly low thermal drift and high signal stability
- Versatile AFM with advanced modes: SRI (conductivity), KPFM (surface potential), SCM (capacitance), MFM (magnetic properties), PFM (piezoelectric forces)
- HybriD ModeTM - quantitative nanomechanical mapping
- Integration with microRaman (optional)

ИК р-СБОМ исследование фазового перехода метаматериала VO₂



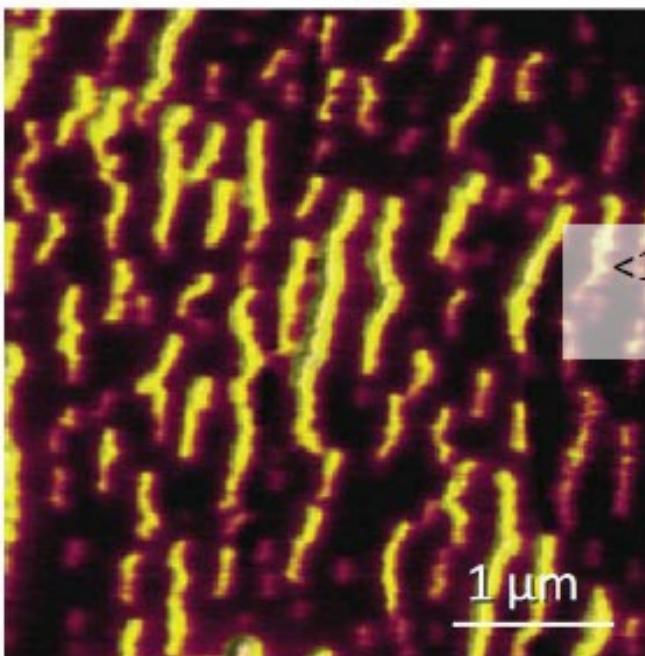
Temperature-dependent infrared near-field images of patterned VO₂/TiO₂ at 11 μm, revealing area-dependent insulator-to-metal phase transitions. The metallic phase is shown in cyan and the insulating phase in red

Gilbert Corder, S. et al. Controlling phase separation in vanadium dioxide thin films via substrate engineering. *Physical Review B* 96, (2017).

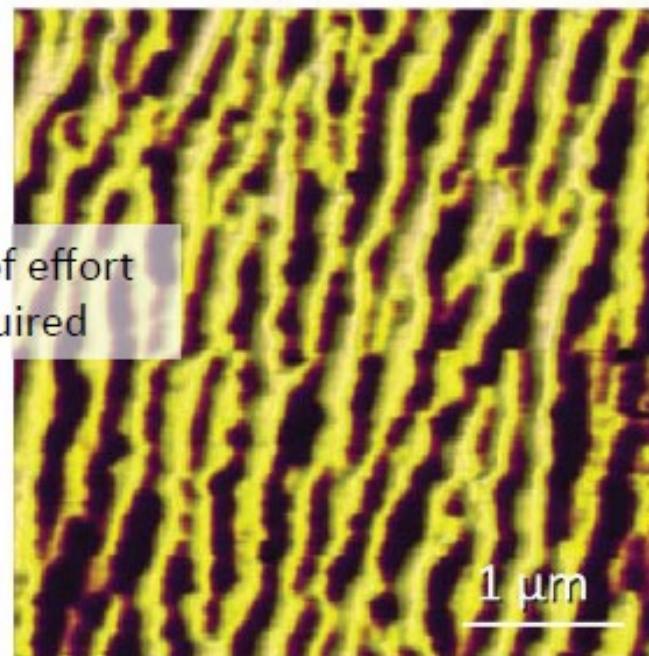
ИК р-СБОМ исследования фазового перехода метаматериала VO₂

IR s-SNOM Reflection

27C



67C

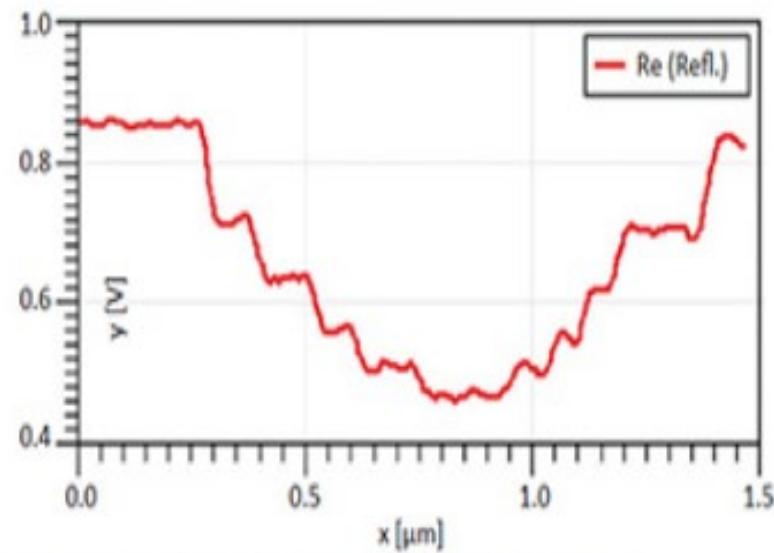
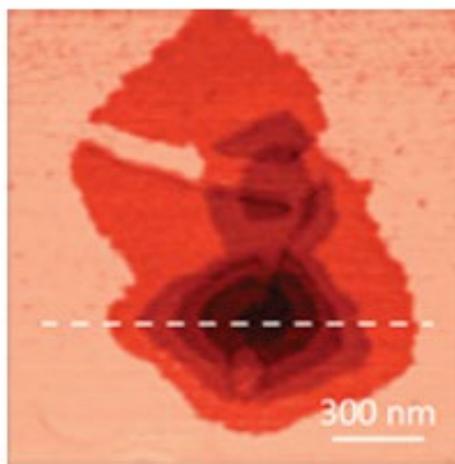
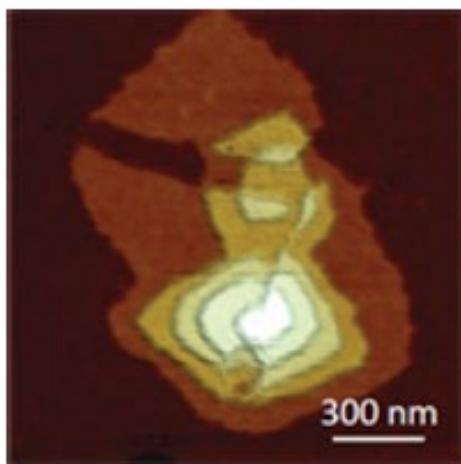


<1hr of effort
required

- Superior high temperature performance: under 1 hour needed to acquire images 40C apart. Compare to days on competitor's system
- Low drift and high signal stability: <1um XY drift from 27 to 67C, no realignment of nanoReflection optics needed

Sample courtesy to prof. Liu (Stony Brook University, New York, USA)

Высокие разрешение и чувствительность методики ИК р-СБОМ на примере исследования монослоев олиготиофенов



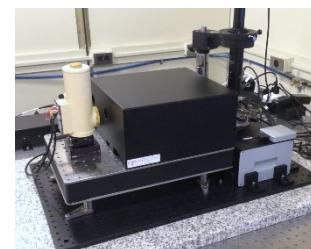
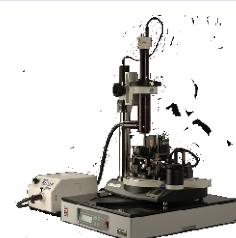
IR reflection contrast of thin and soft structures easily detectable. Each of five 3.4 nm steps is resolved. Spatial resolution is better than $\lambda/1000$.

Sample courtesy to Dr. A. Mourran (DWI, Aachen, Germany). Measured by Dr. G. Andreev (EVS Co)

Продуктовая линейка НТ-МДТ Спектрум Инструментс

AFM

AFM-Raman / IR / TERS



SOLVER NANO	NEXT/ TITANIUM	NTEGRA	VEGA	NTEGRA SPECTRA II	NTEGRA Nano IR
<ul style="list-style-type: none">Compact desktop AFM/STM for both education and scienceFull set of AFM/STM modesHigh AFM/STM performanceClosed-loop Scanner	<ul style="list-style-type: none">AFM/STM with exceptional level of automationFast, precise and low-noise closed-loop scannerHigh resolution imaging due to extremely low noise and high stabilityFull set of standard and advanced AFM/STM modesHybrid Mode™	<ul style="list-style-type: none">Modular high performance AFM/STM for wide range of applicationsLow noise and high resolutionFull set of standard and advanced AFM/STM modesHybrid Mode™	<ul style="list-style-type: none">Automated high-resolution AFM for up to 200x200 mm samplesUltra stable AFMFull set of standard and advanced AFM modesHybrid Mode™ScanTronic™	<ul style="list-style-type: none">SPMAutomated AFM laser, probe and photodiodeConfocal Raman / Fluorescence / Rayleigh MicroscopyTip Enhanced Raman Scattering (TERS)TERS optimized system for all possible excitation/detection geometriesHybrid Mode™	<ul style="list-style-type: none">IR sSNOM systemHigh resolution AFMStabilized CO₂ laserHybrid Mode™

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